

OPTICAL SIGNAL QUALITY MONITORING CIRCUIT AND OPTICAL
SIGNAL QUALITY MONITORING METHOD

Inventors: Hidehiko Takara et al.

Docket No. 14321.87

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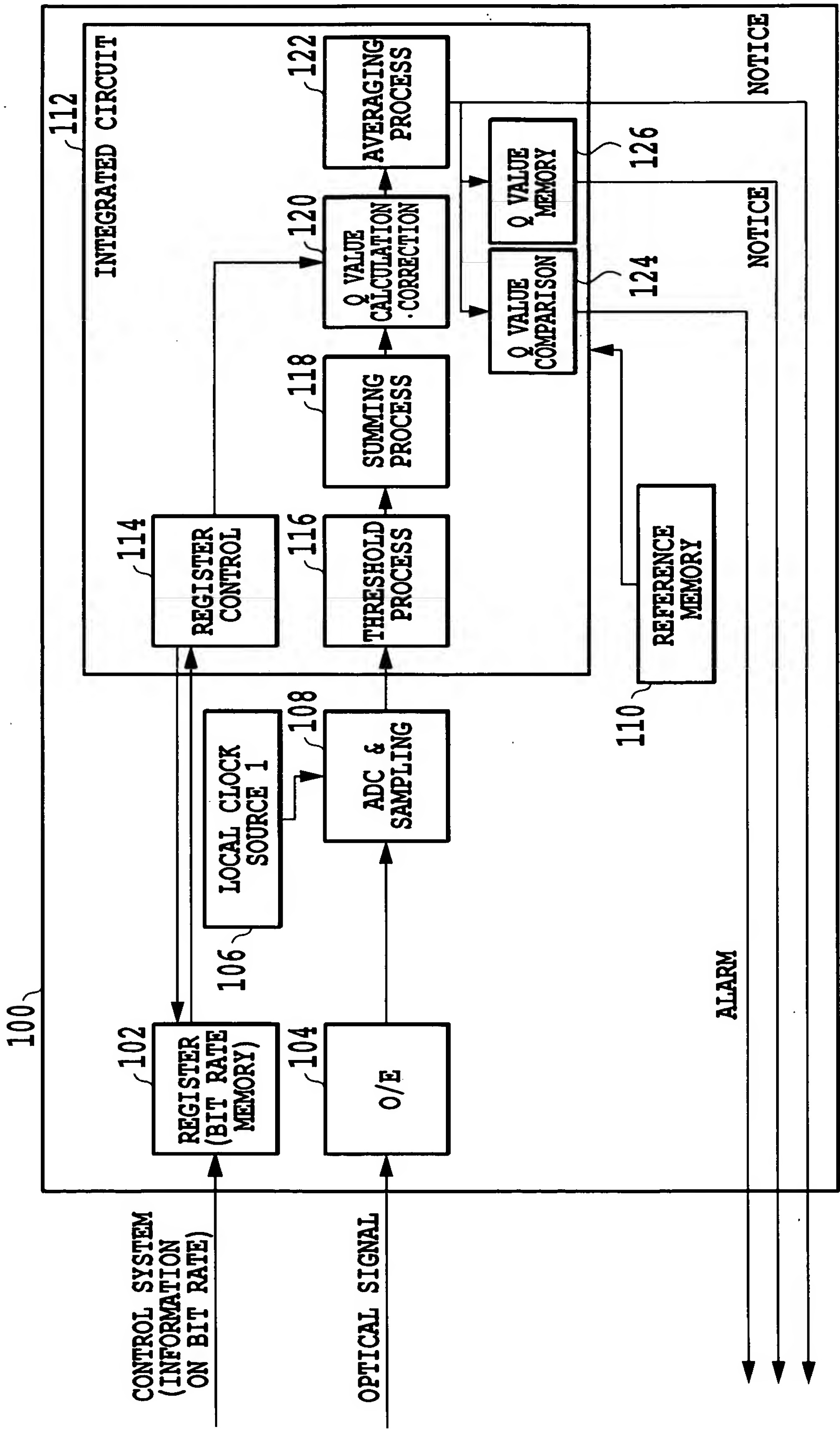


FIG.1

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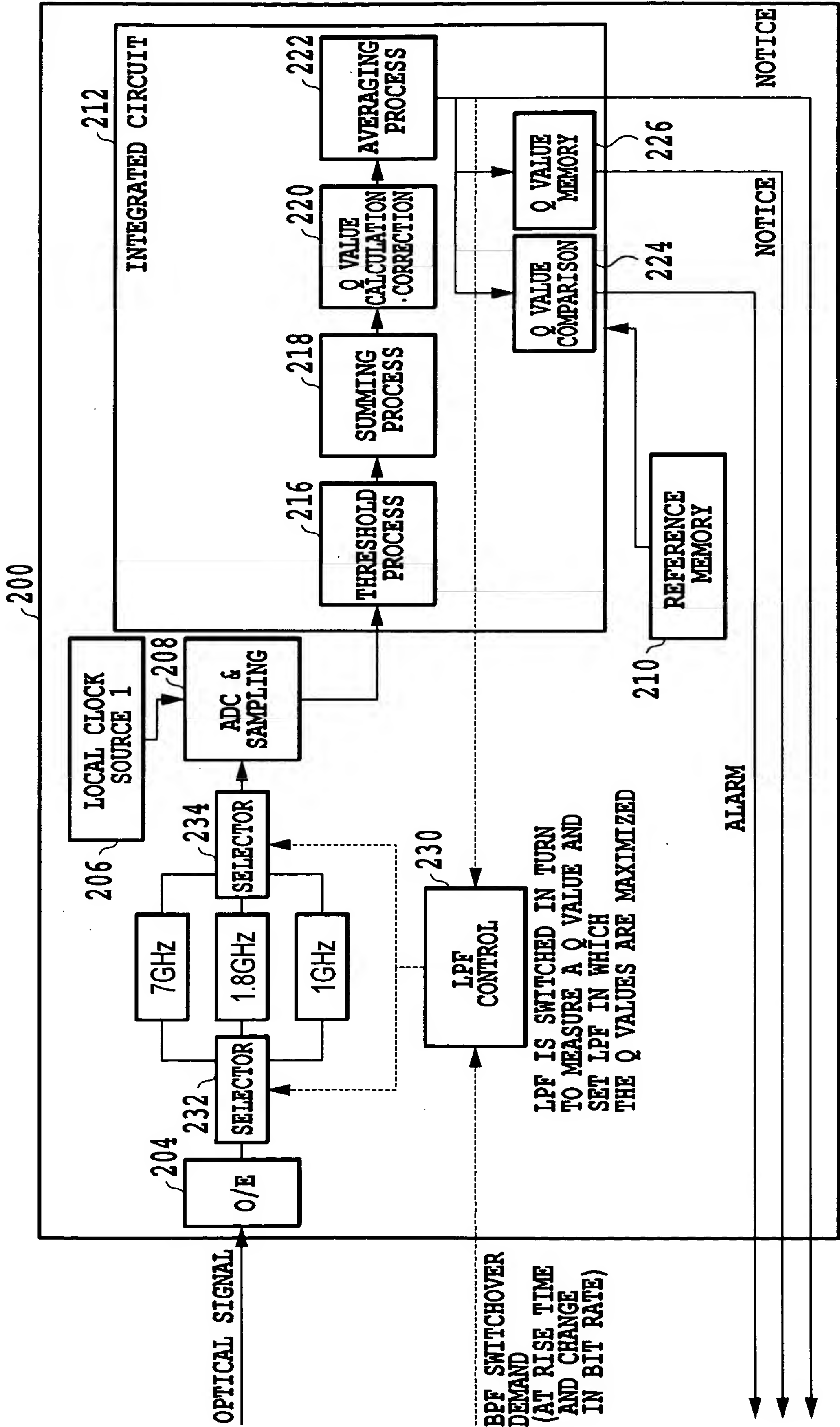


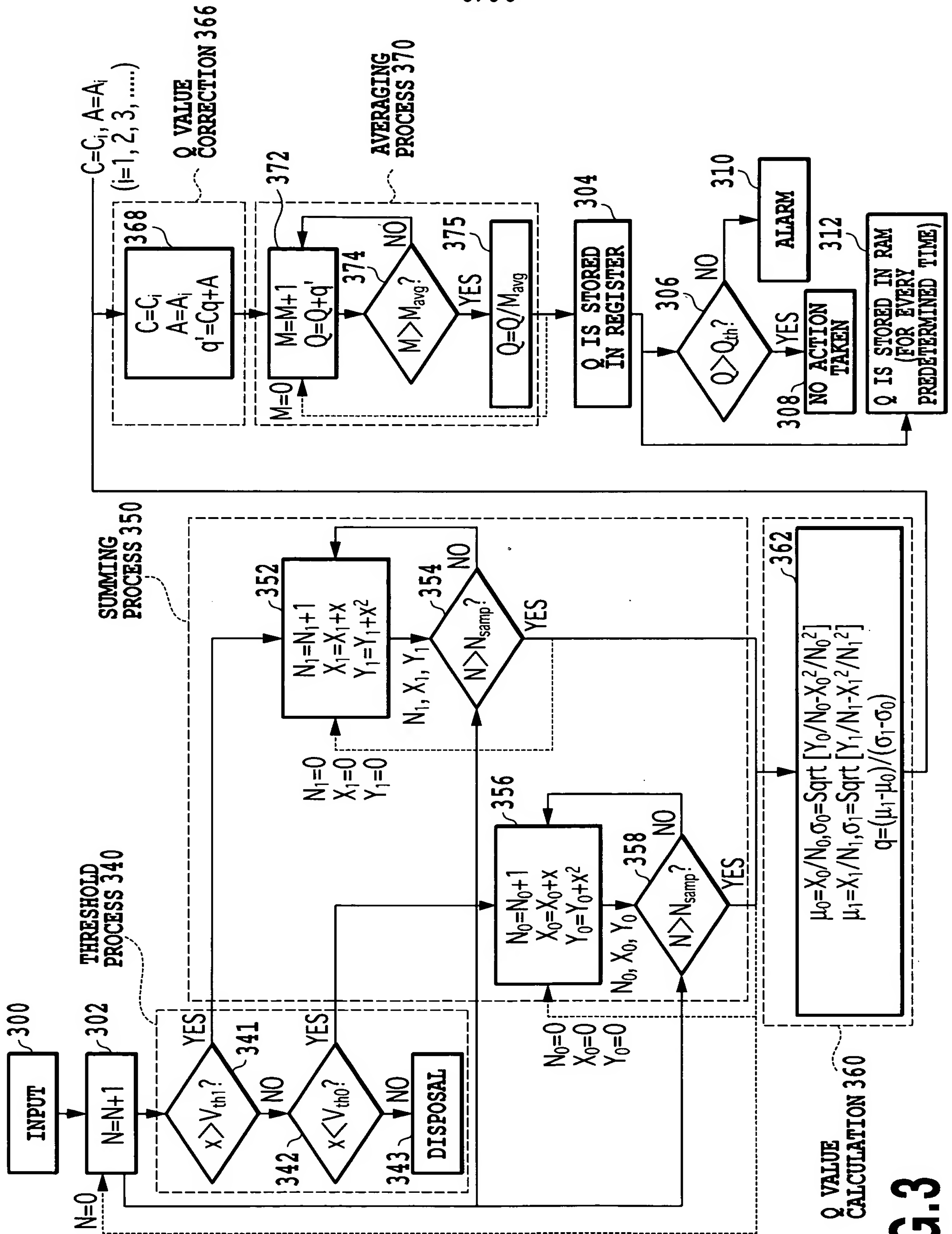
FIG.2

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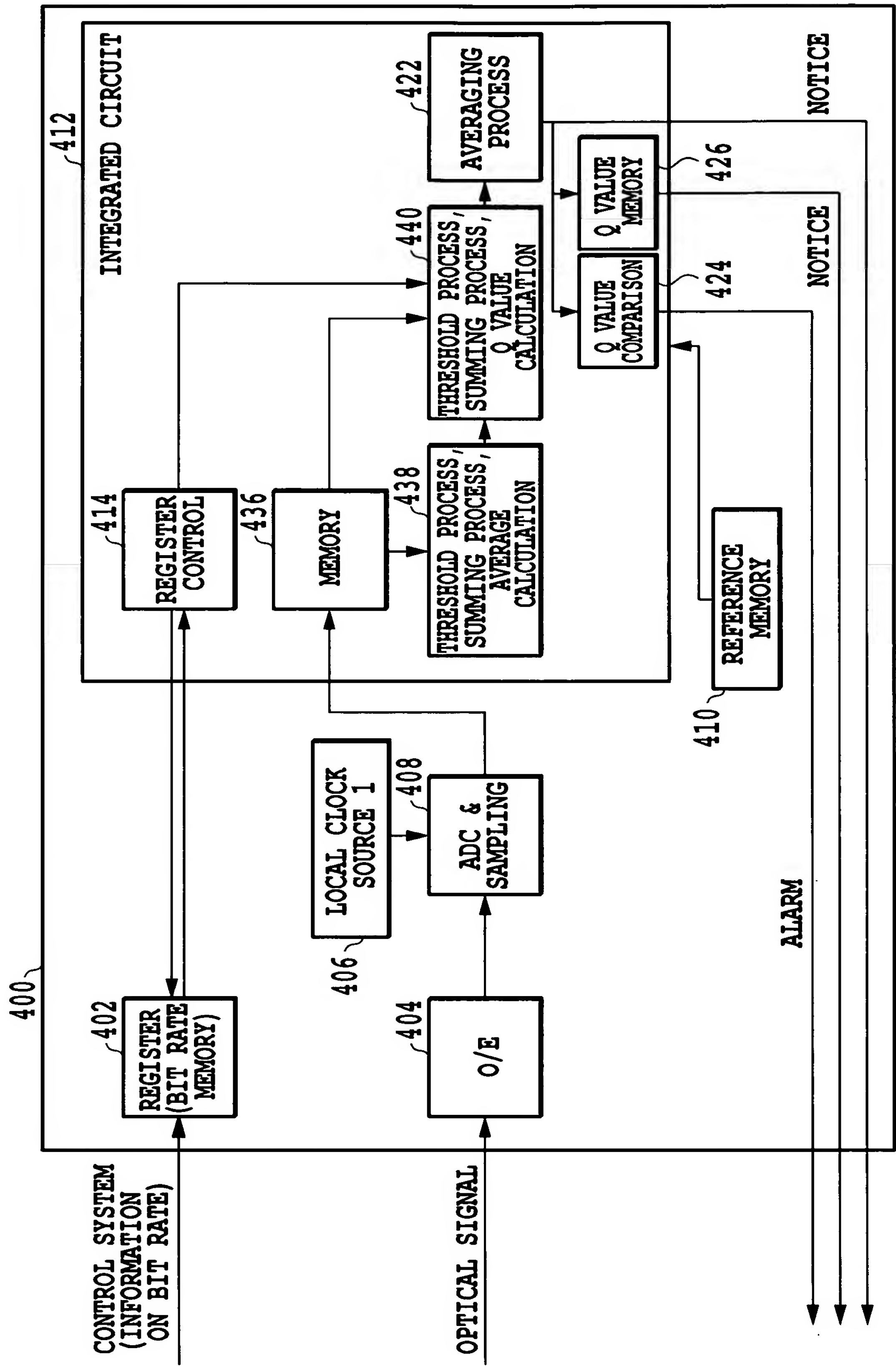
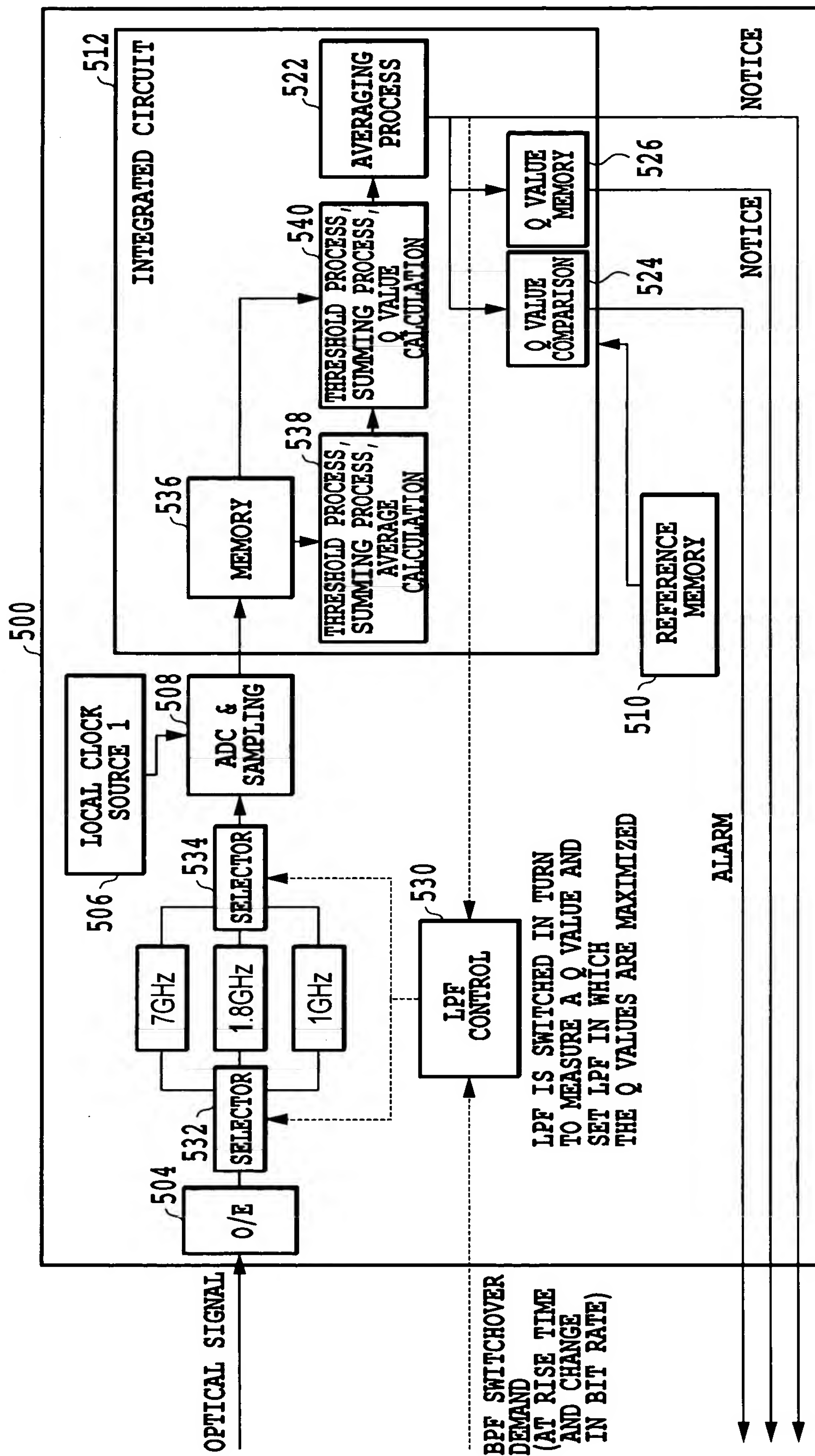


FIG.4

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FIG. 5



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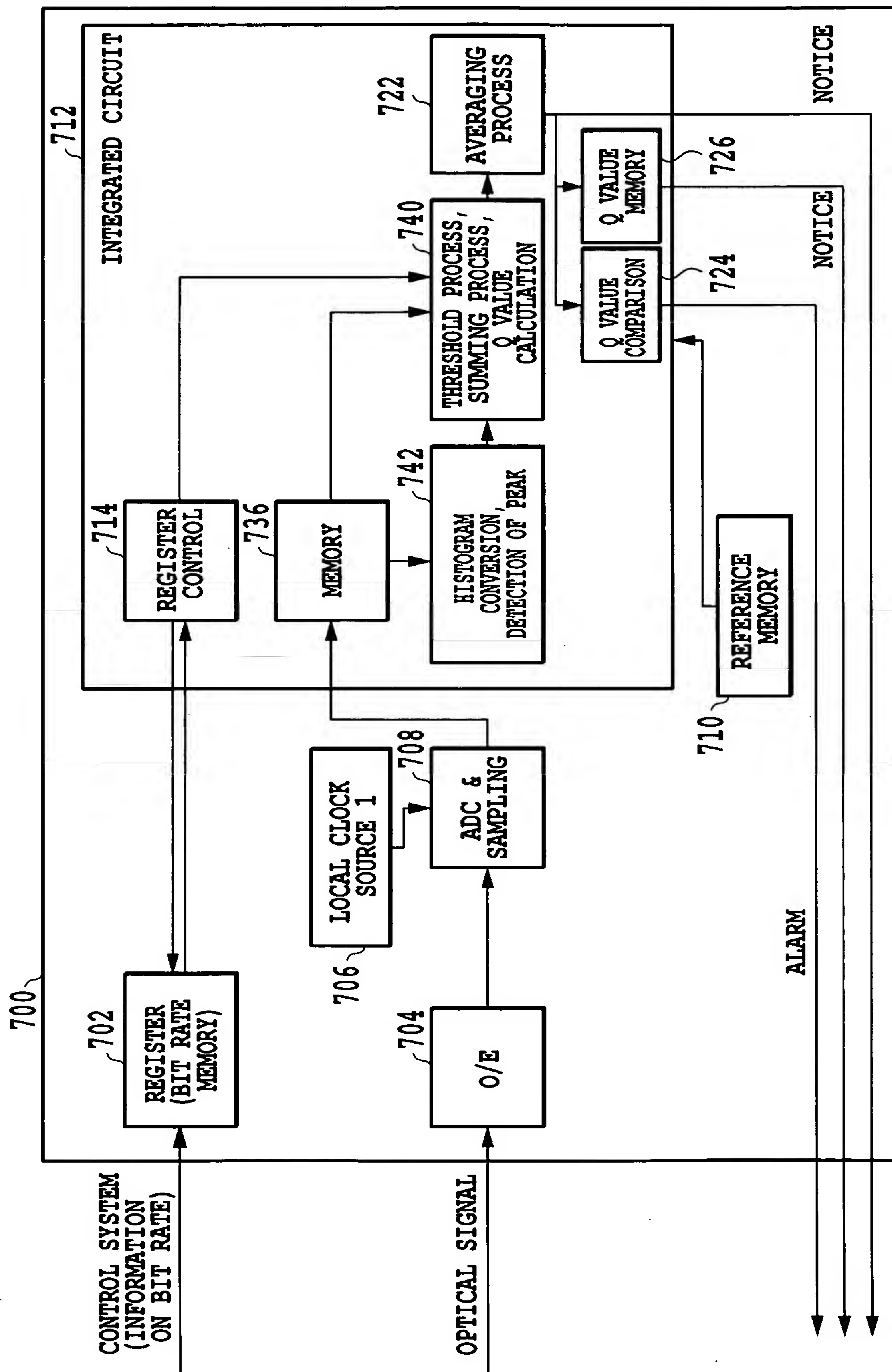


FIG. 7

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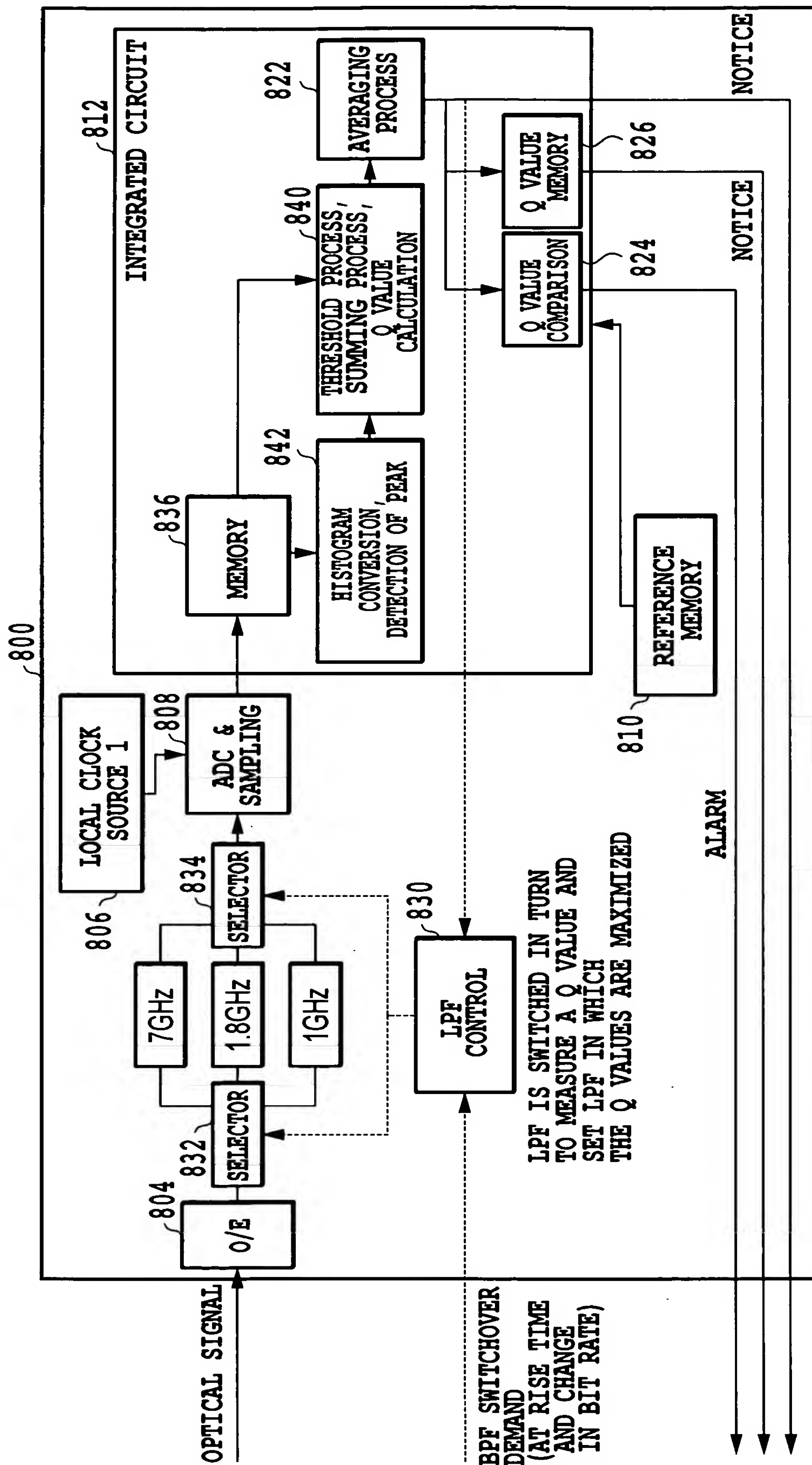


FIG.8

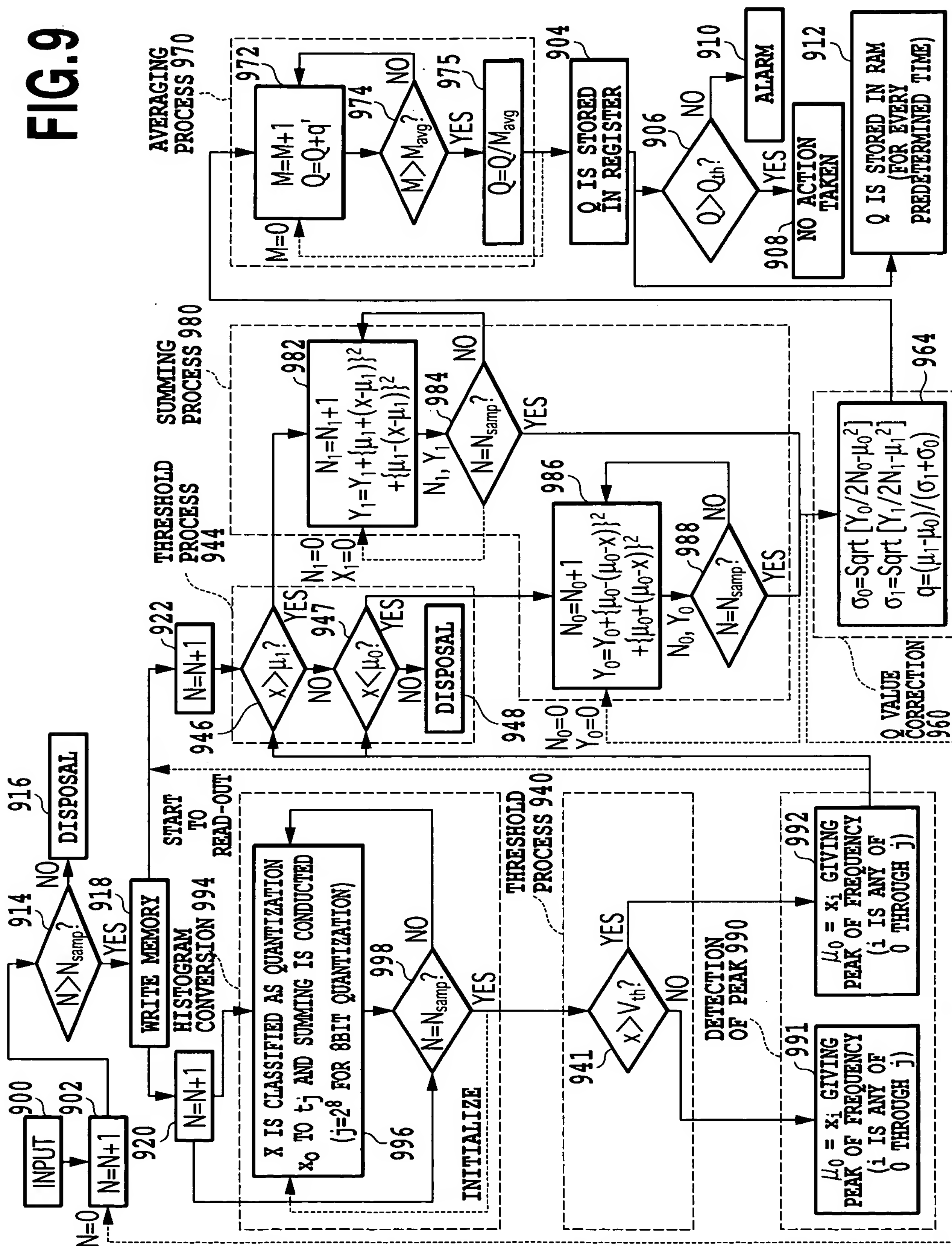
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FIG.9



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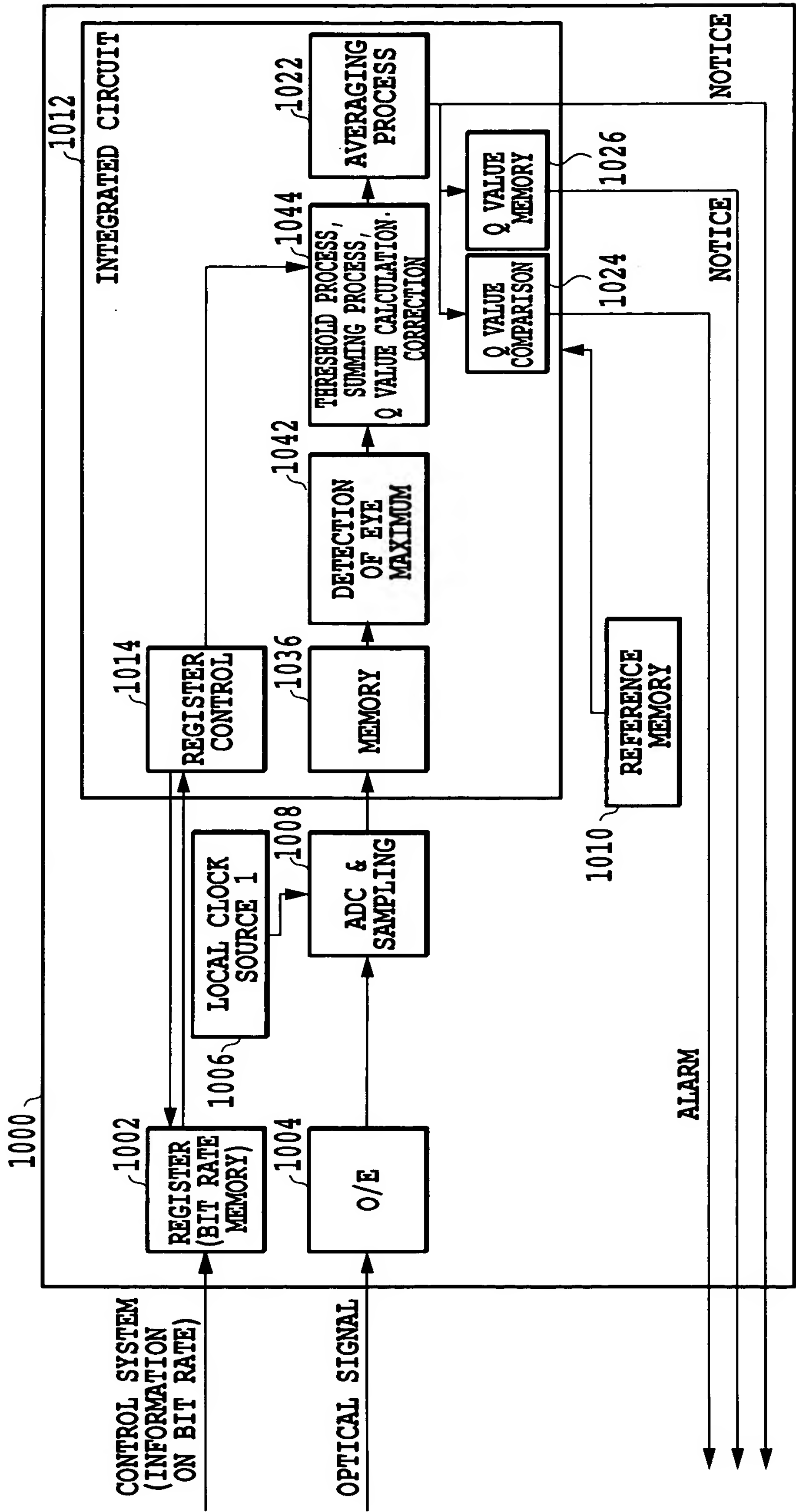
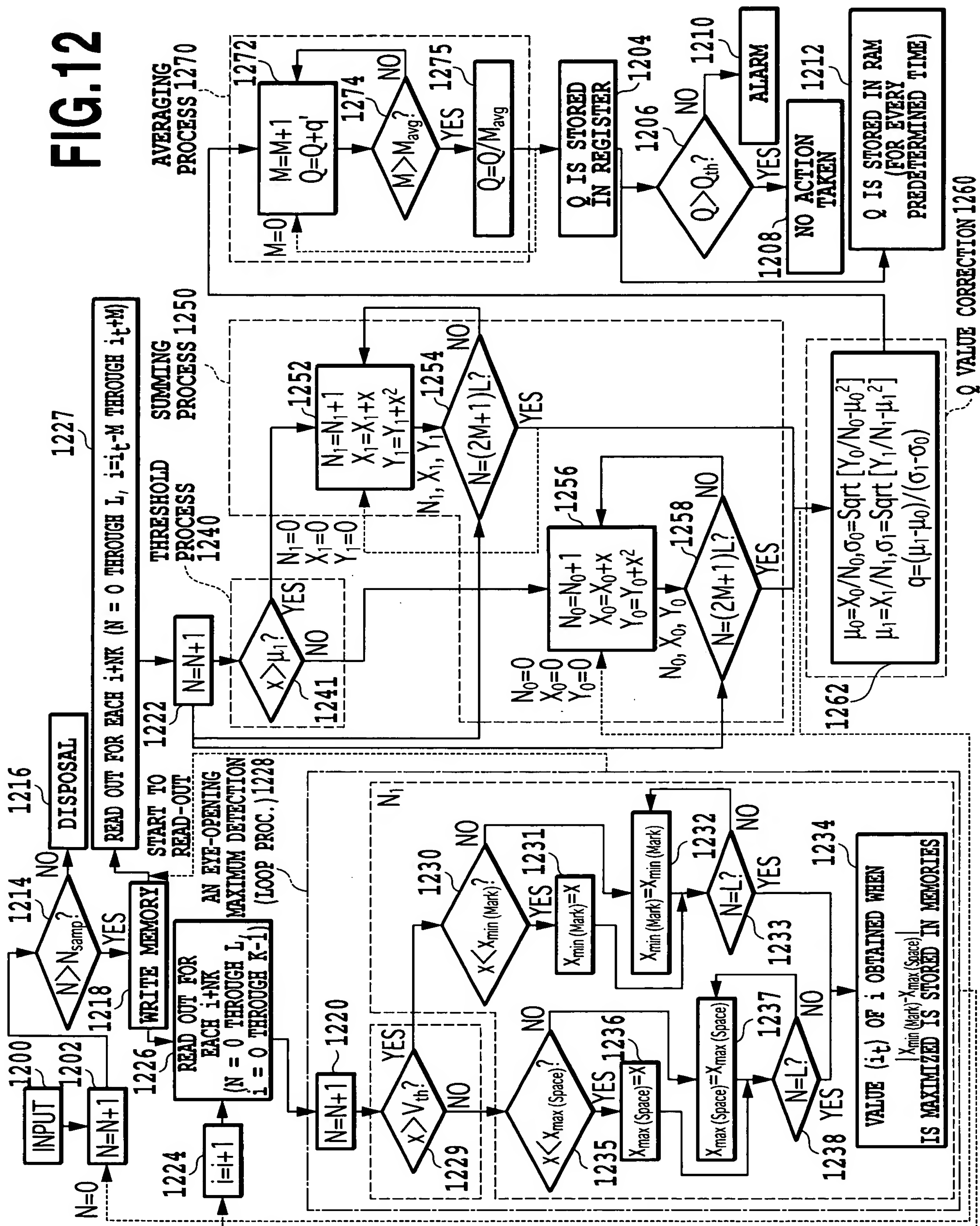


FIG.10

FIG. 12



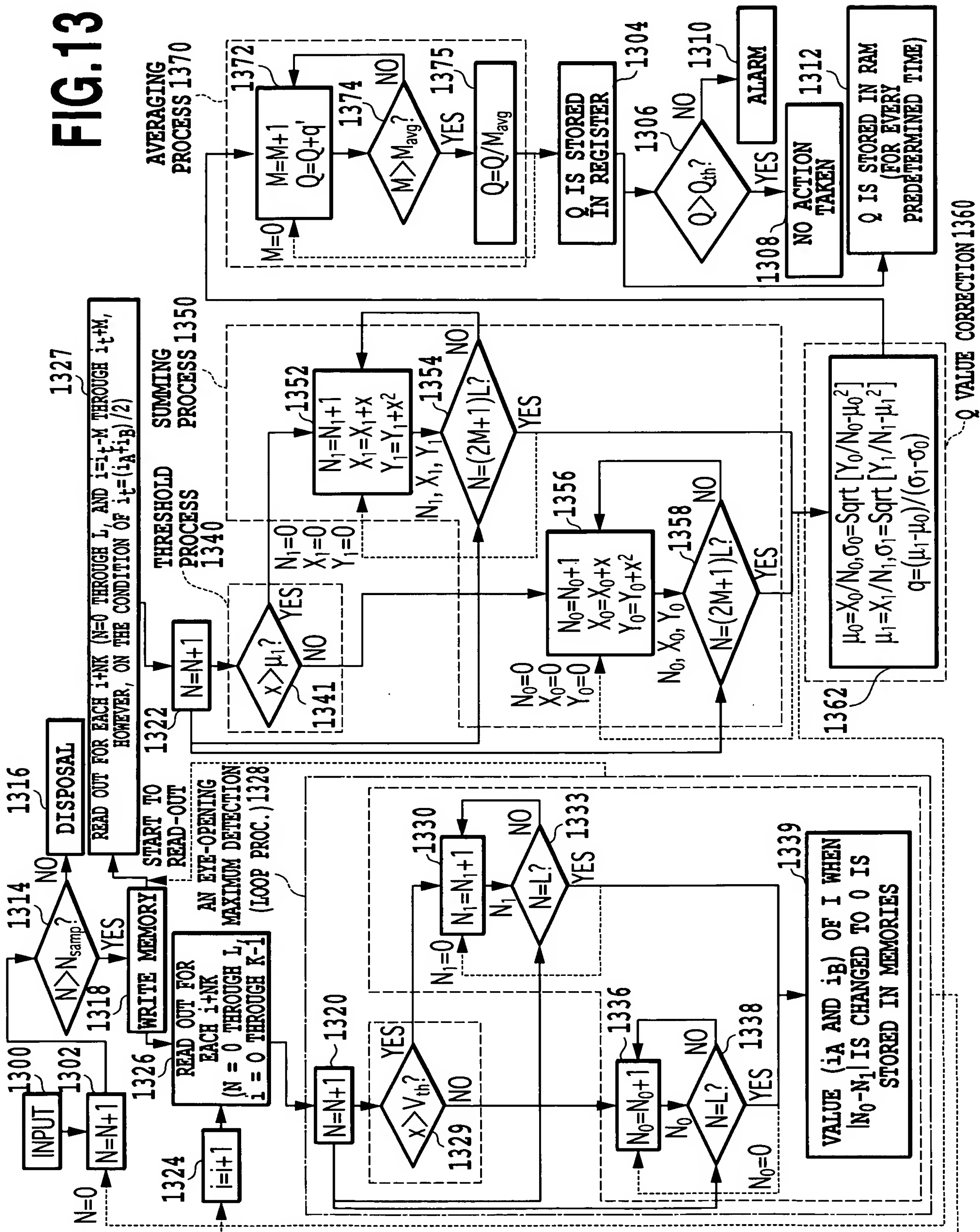
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FIG. 13



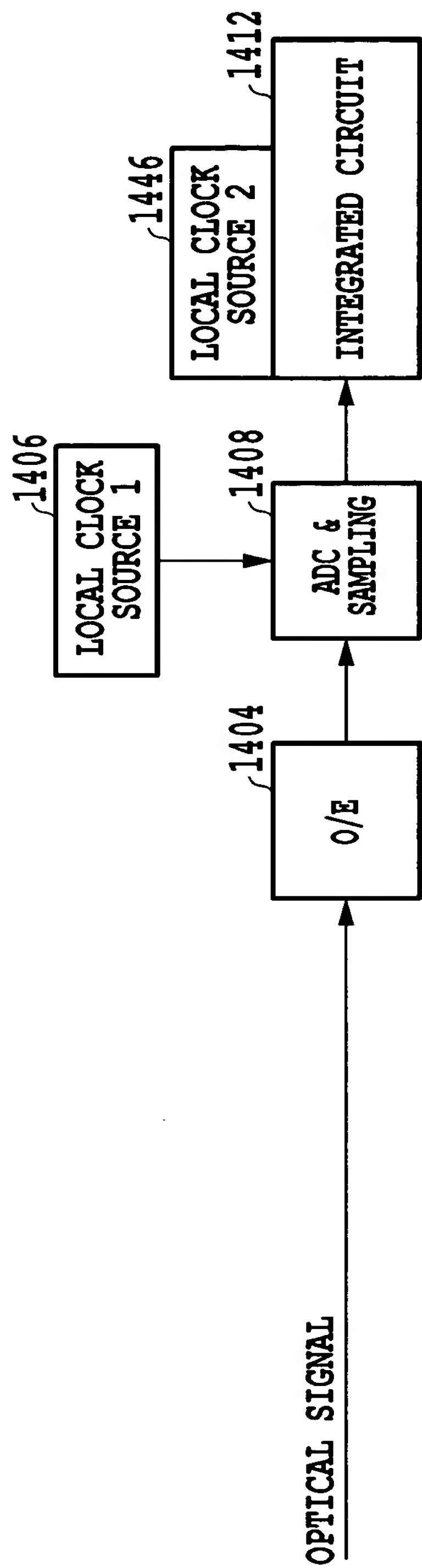


FIG.14

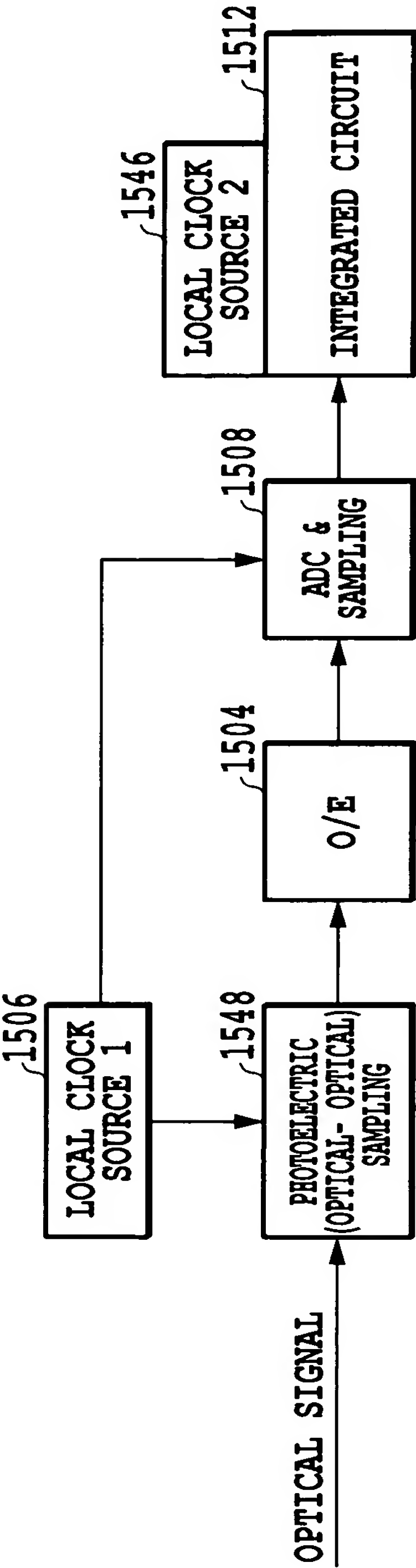


FIG.15

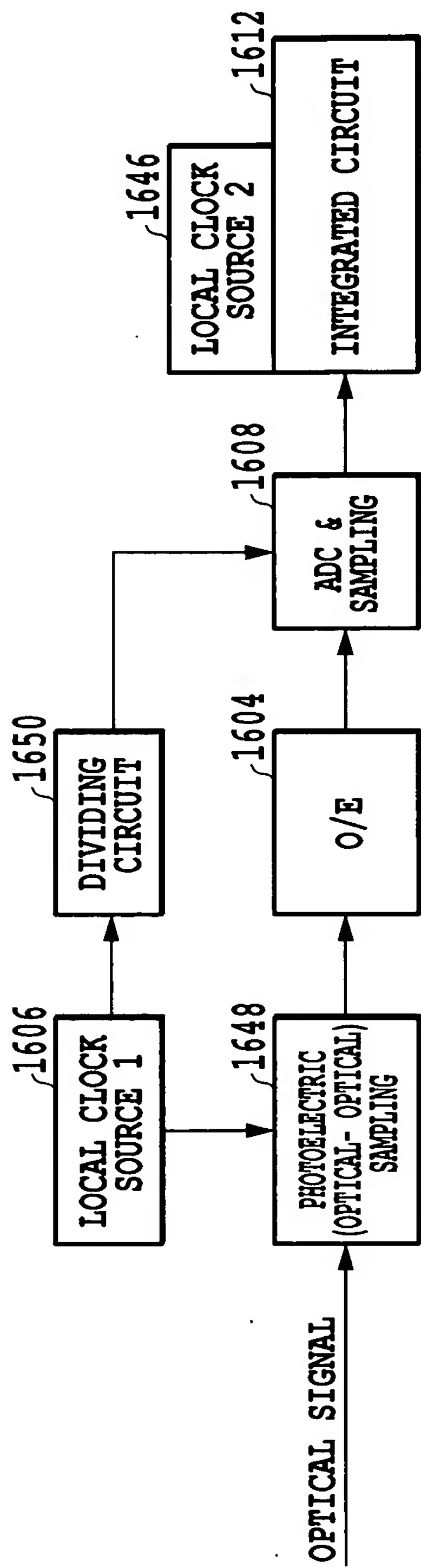


FIG.16

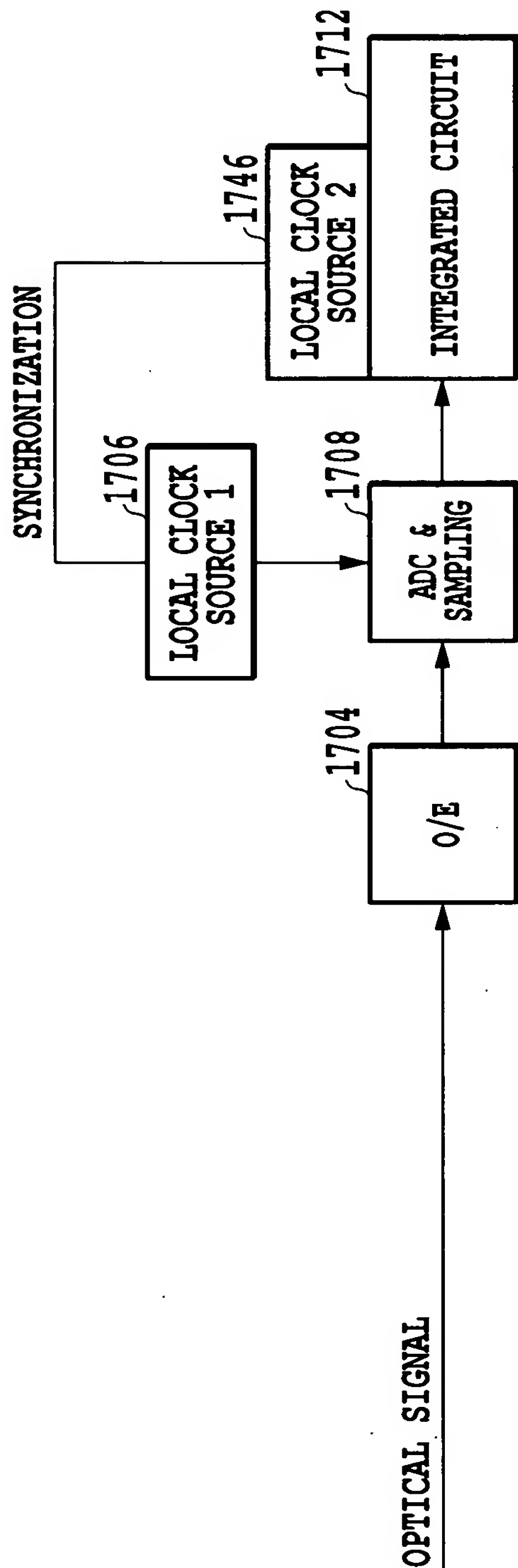


FIG.17

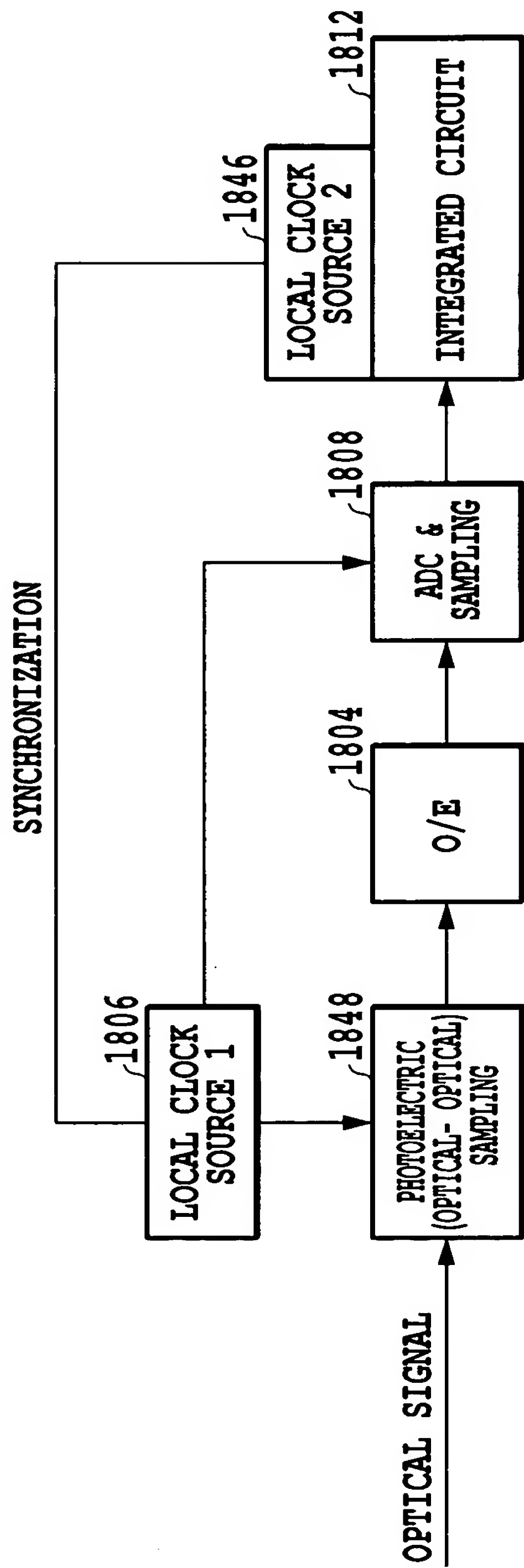


FIG.18

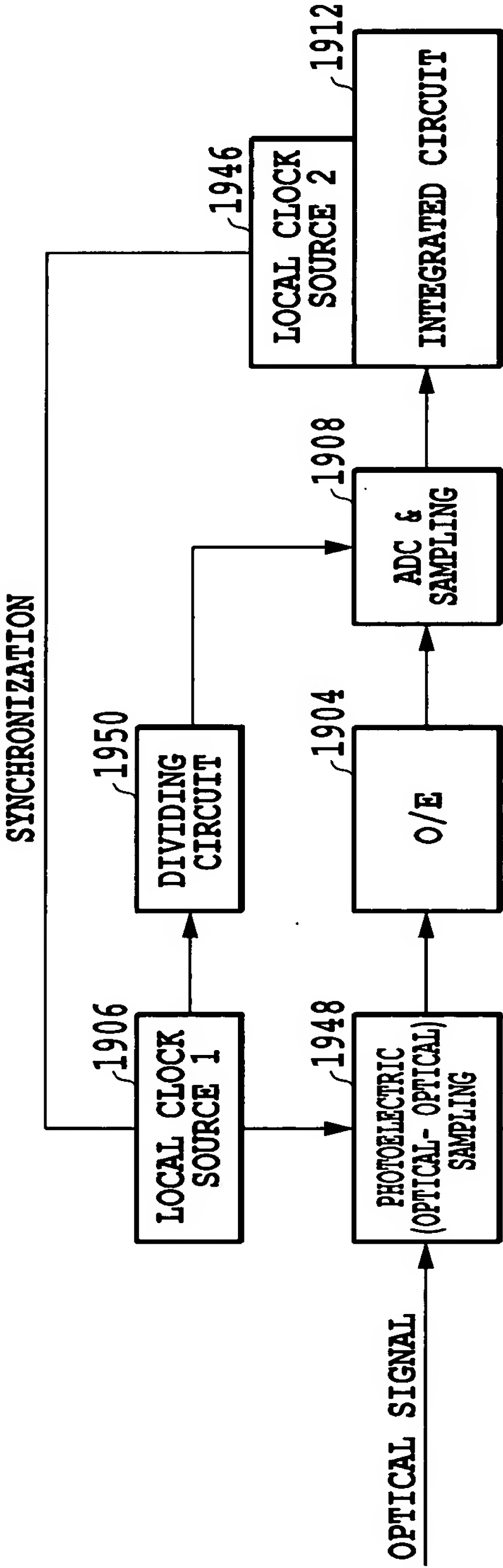


FIG.19

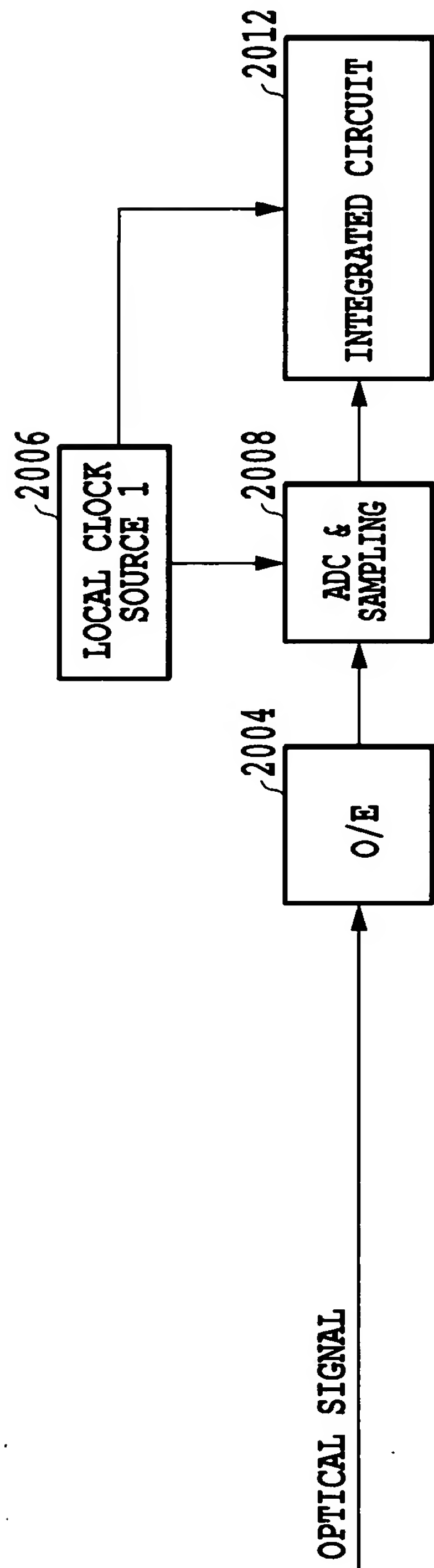


FIG.20

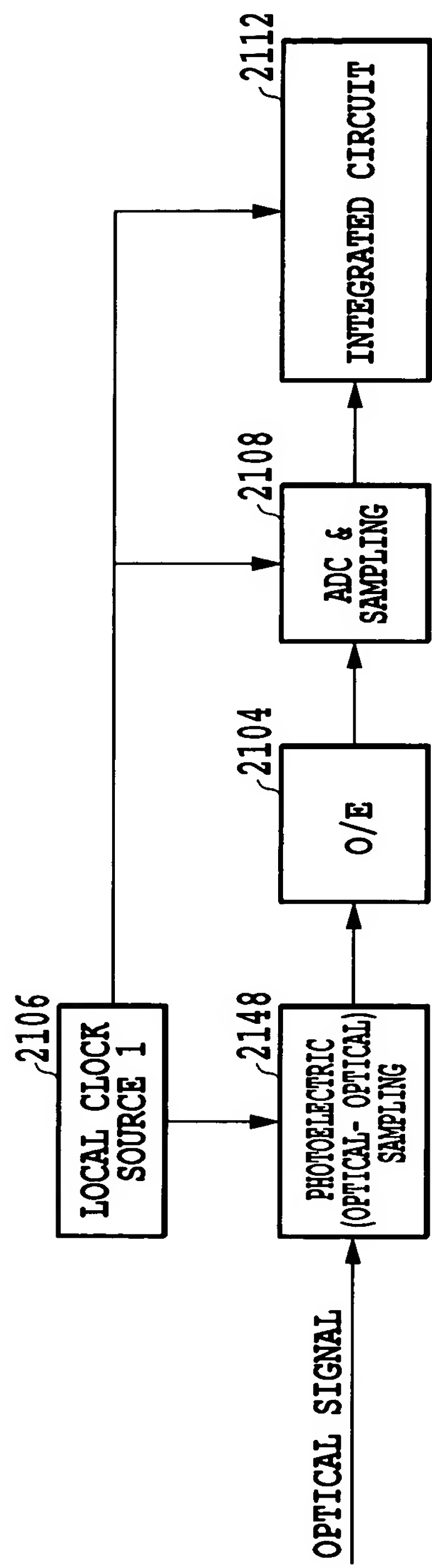


FIG.21

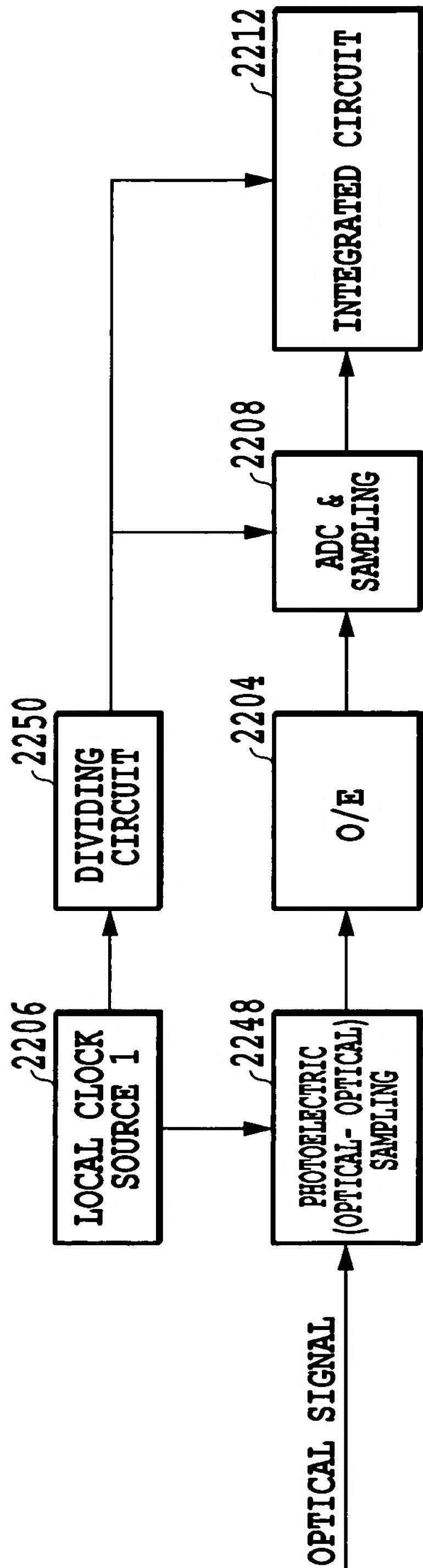


FIG.22

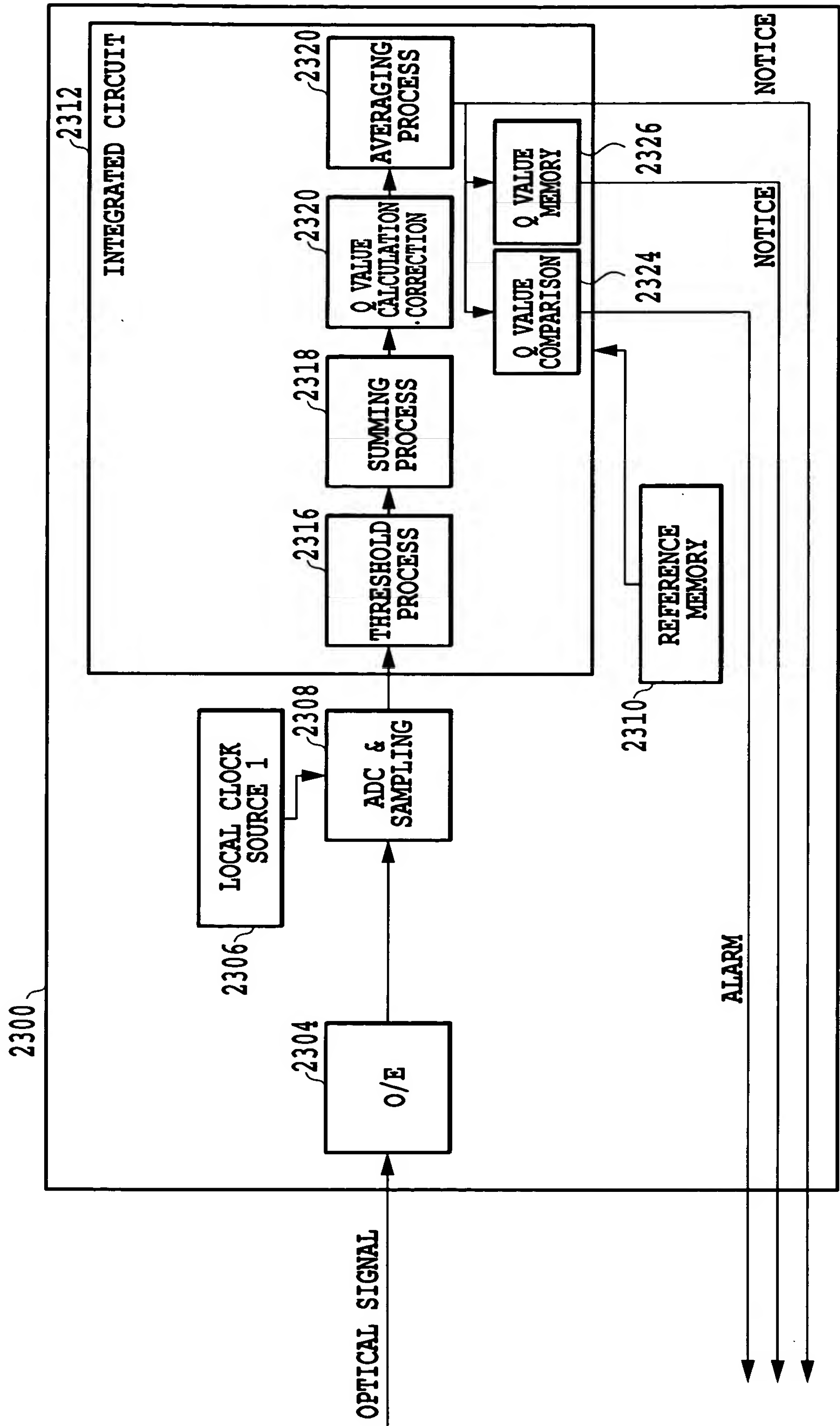
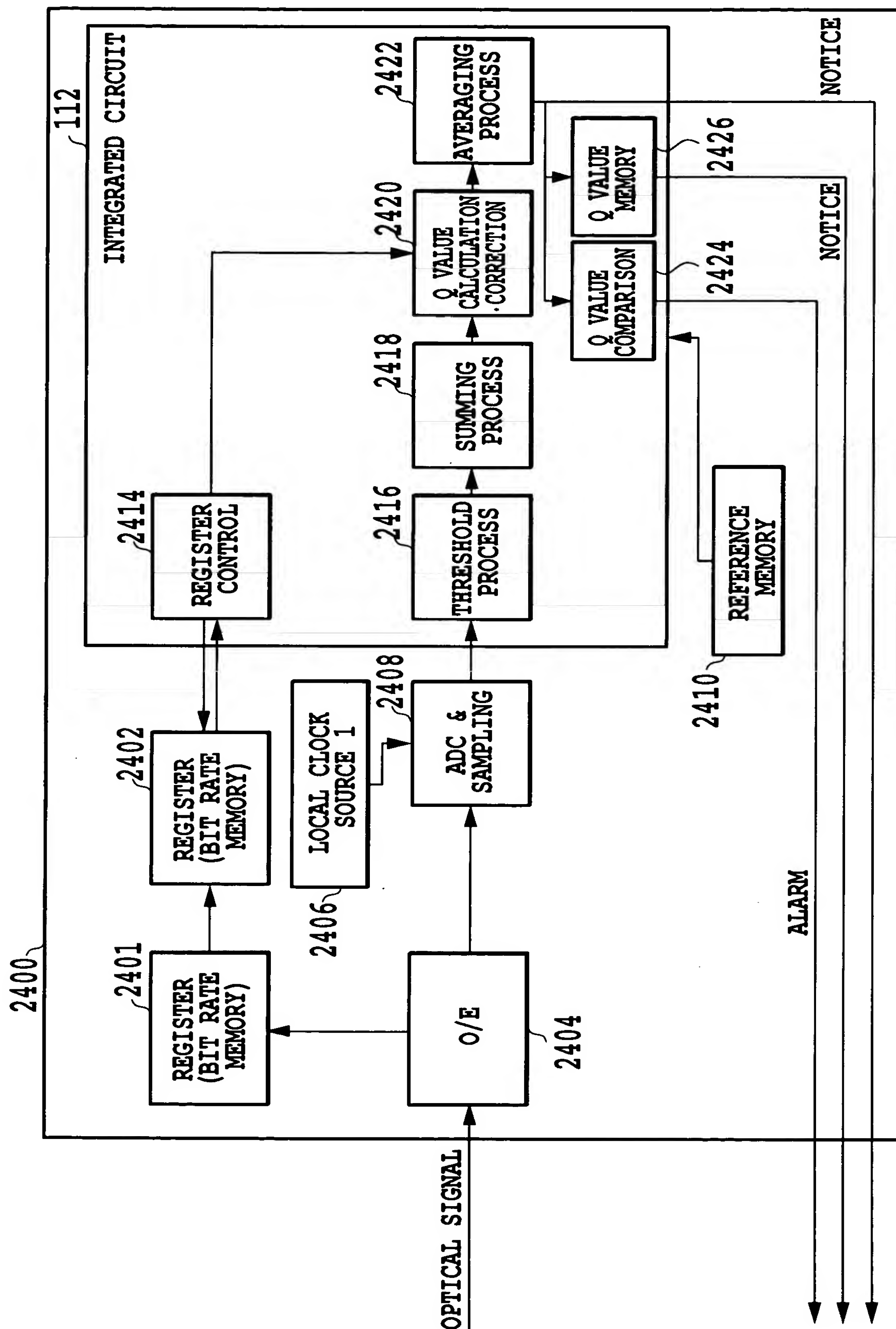


FIG.23

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FIG. 24



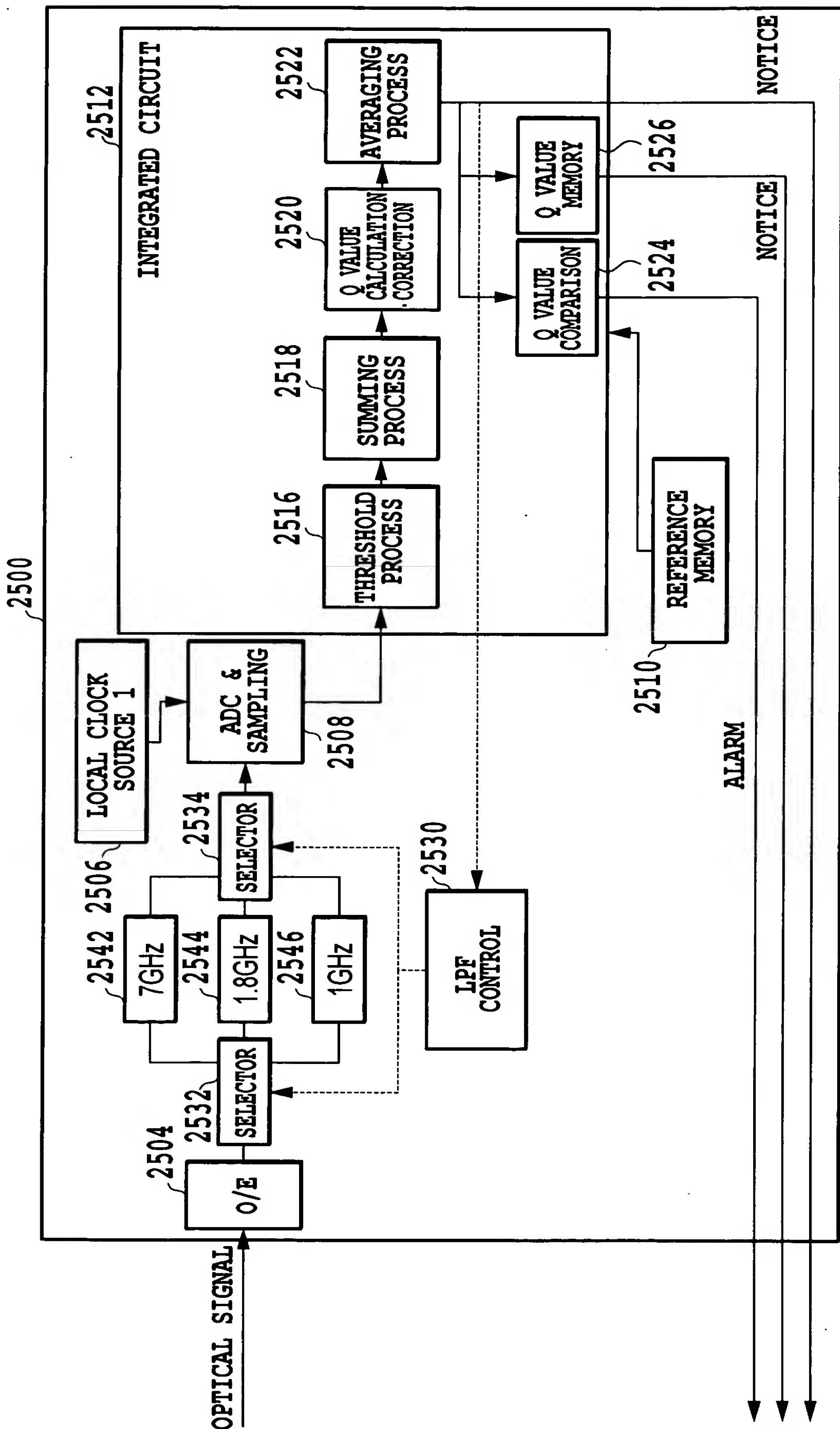


FIG.25

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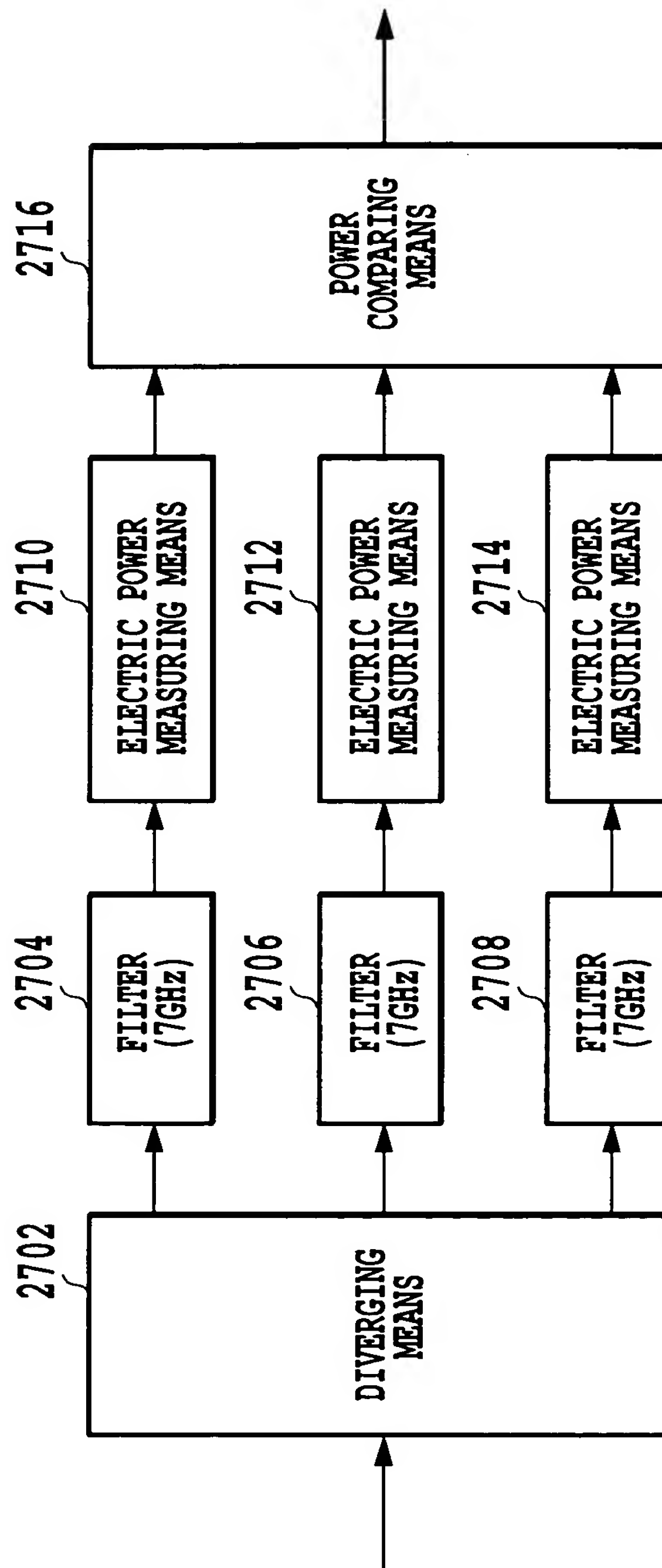


FIG.27

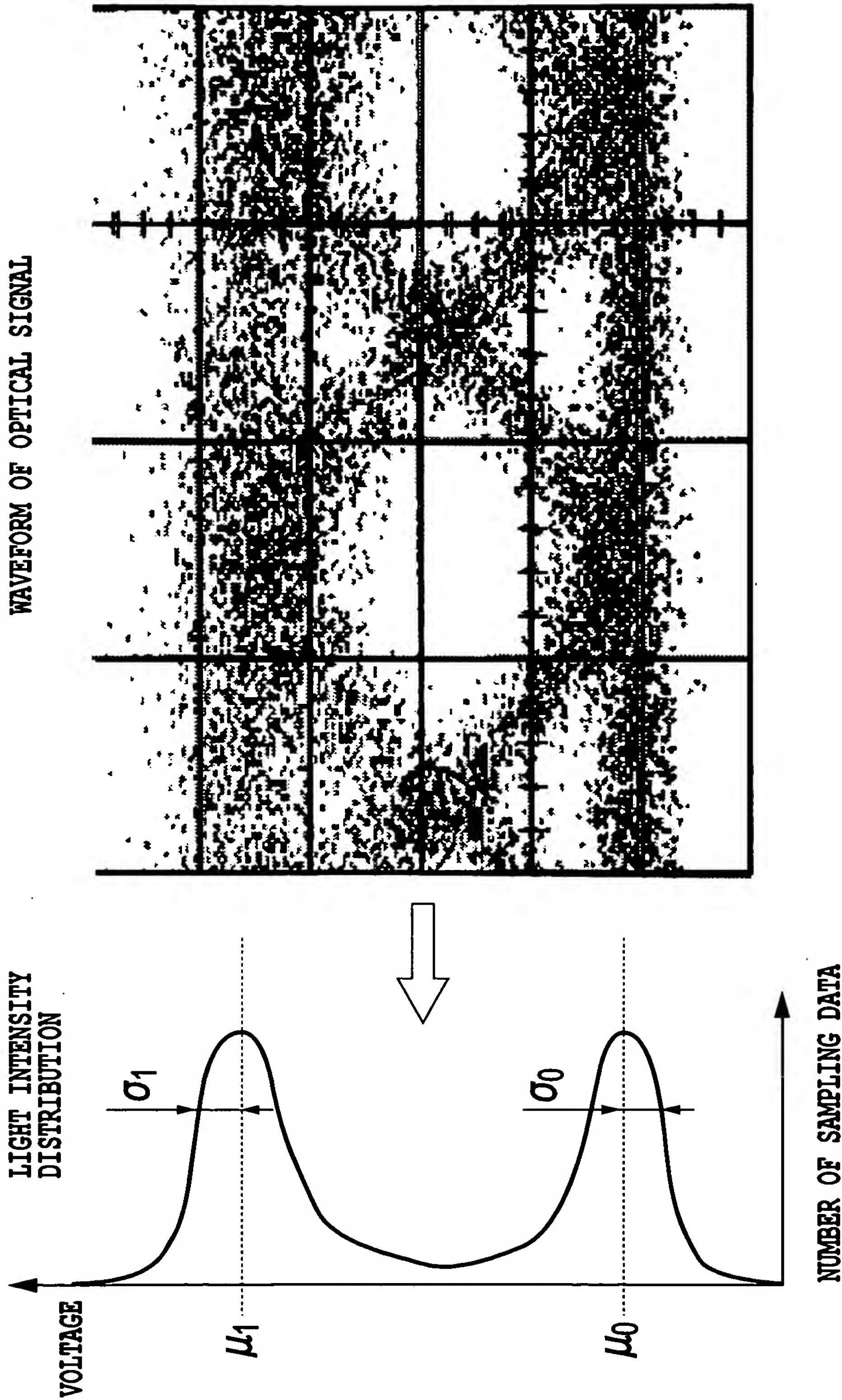


FIG.28

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FIG.29

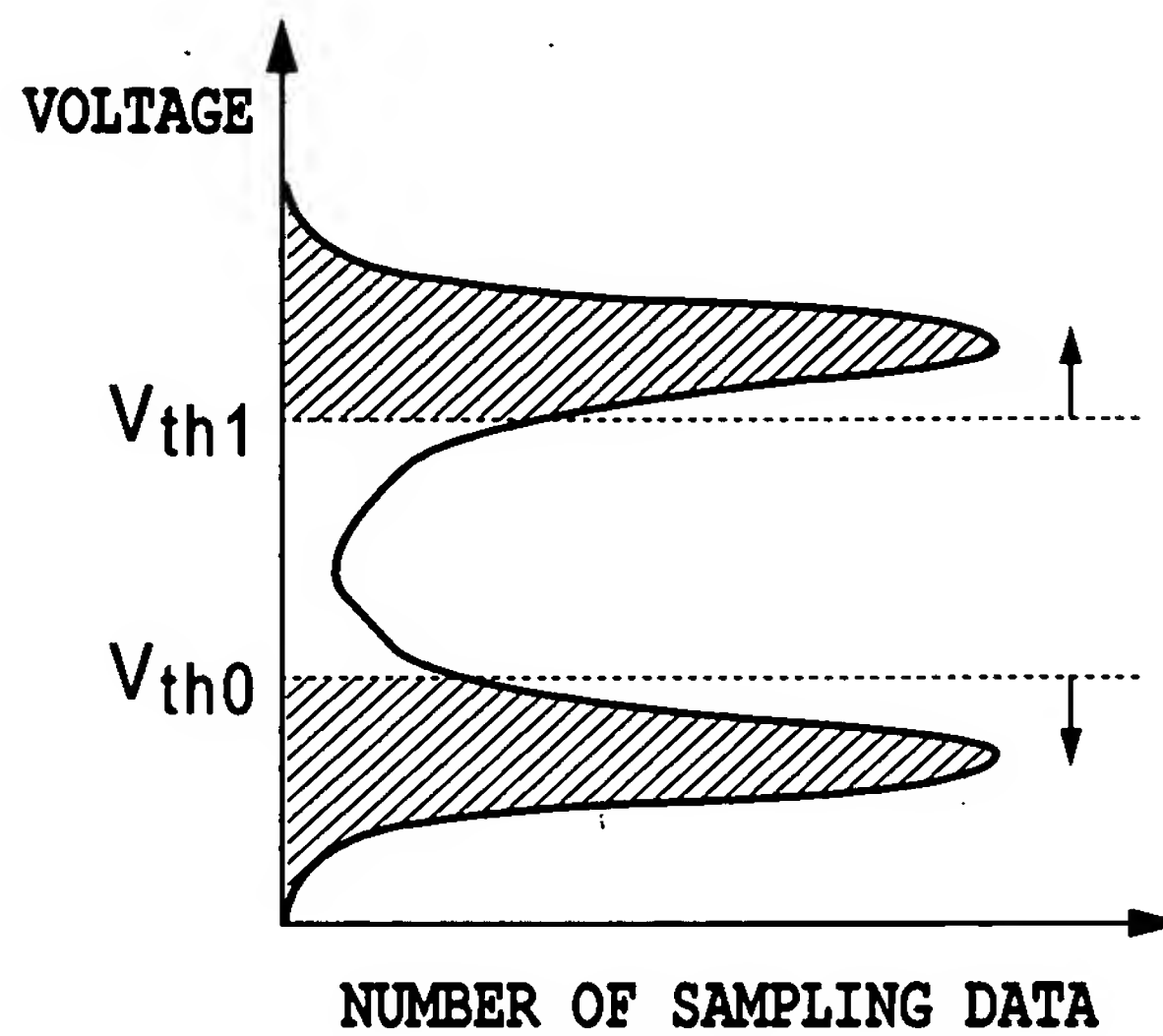


FIG.30

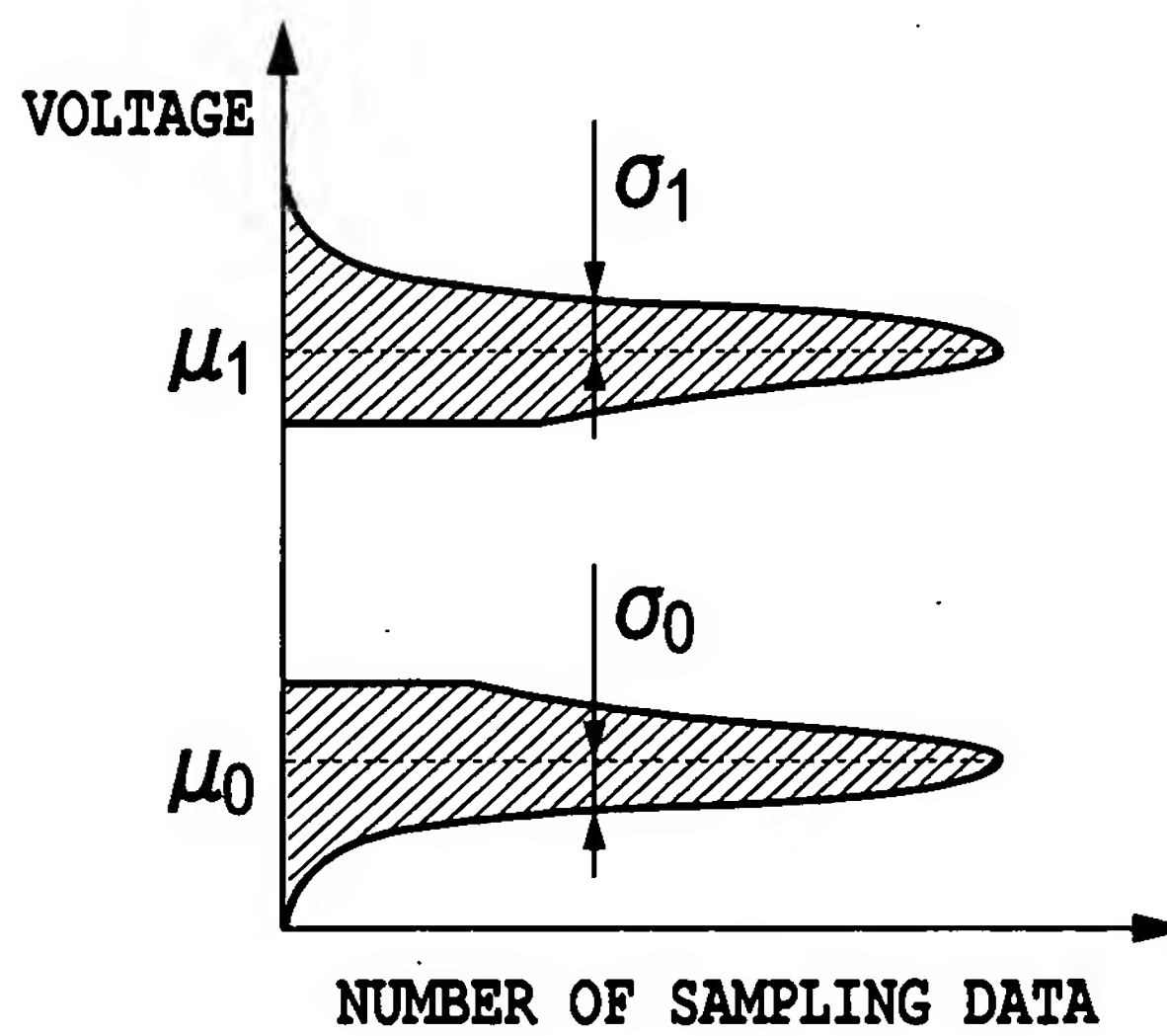


FIG.31

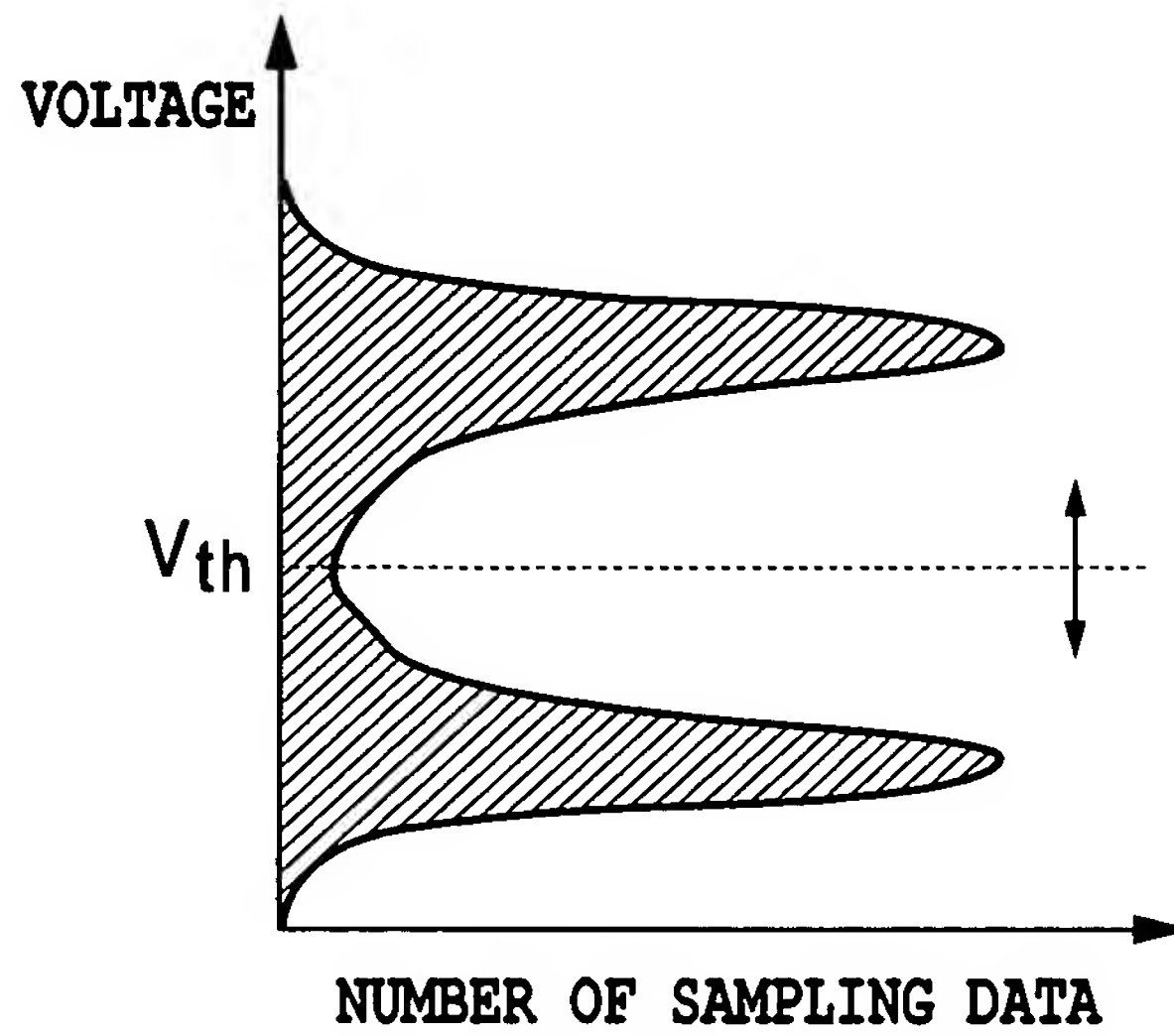
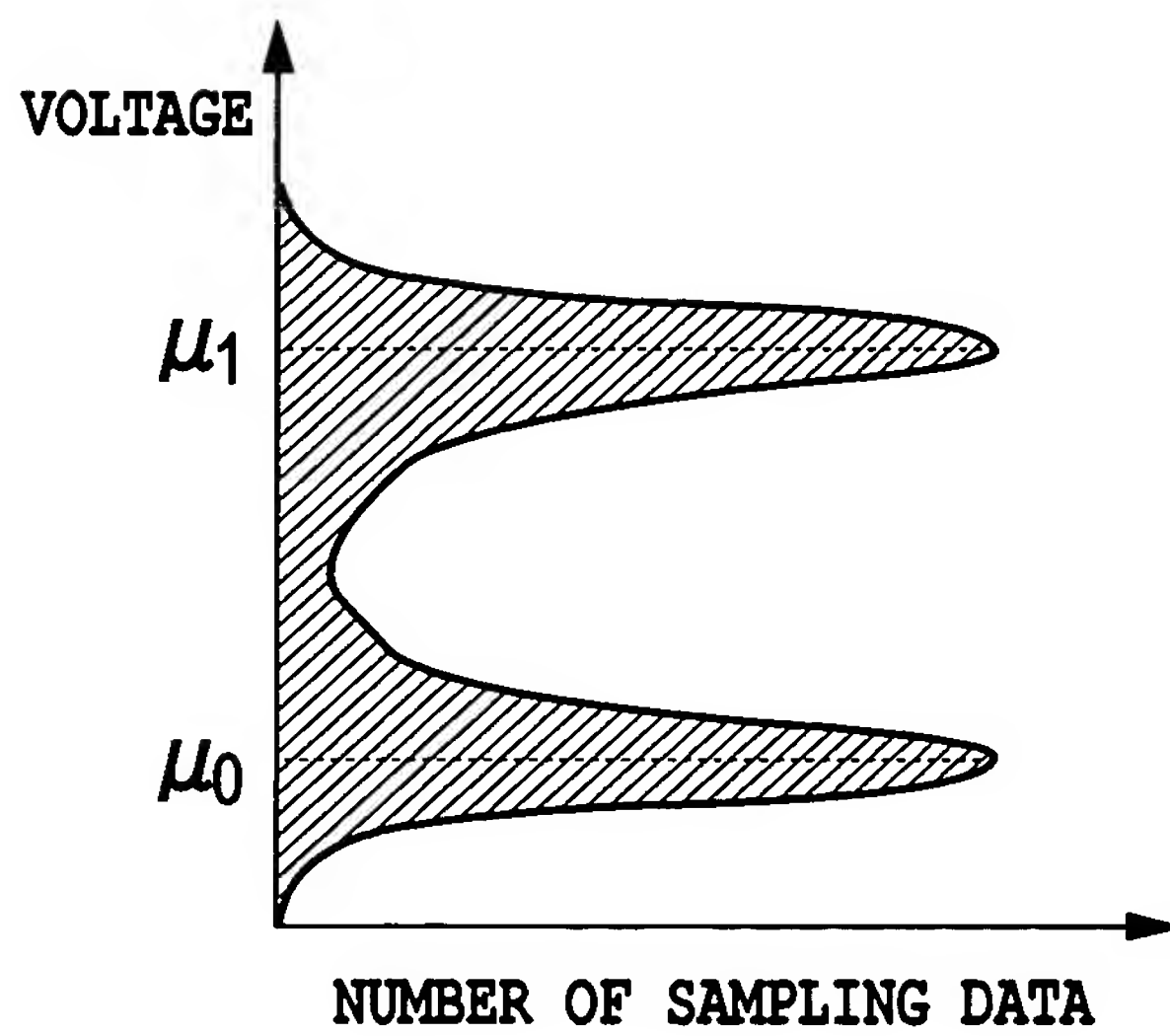


FIG.32



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FIG.33

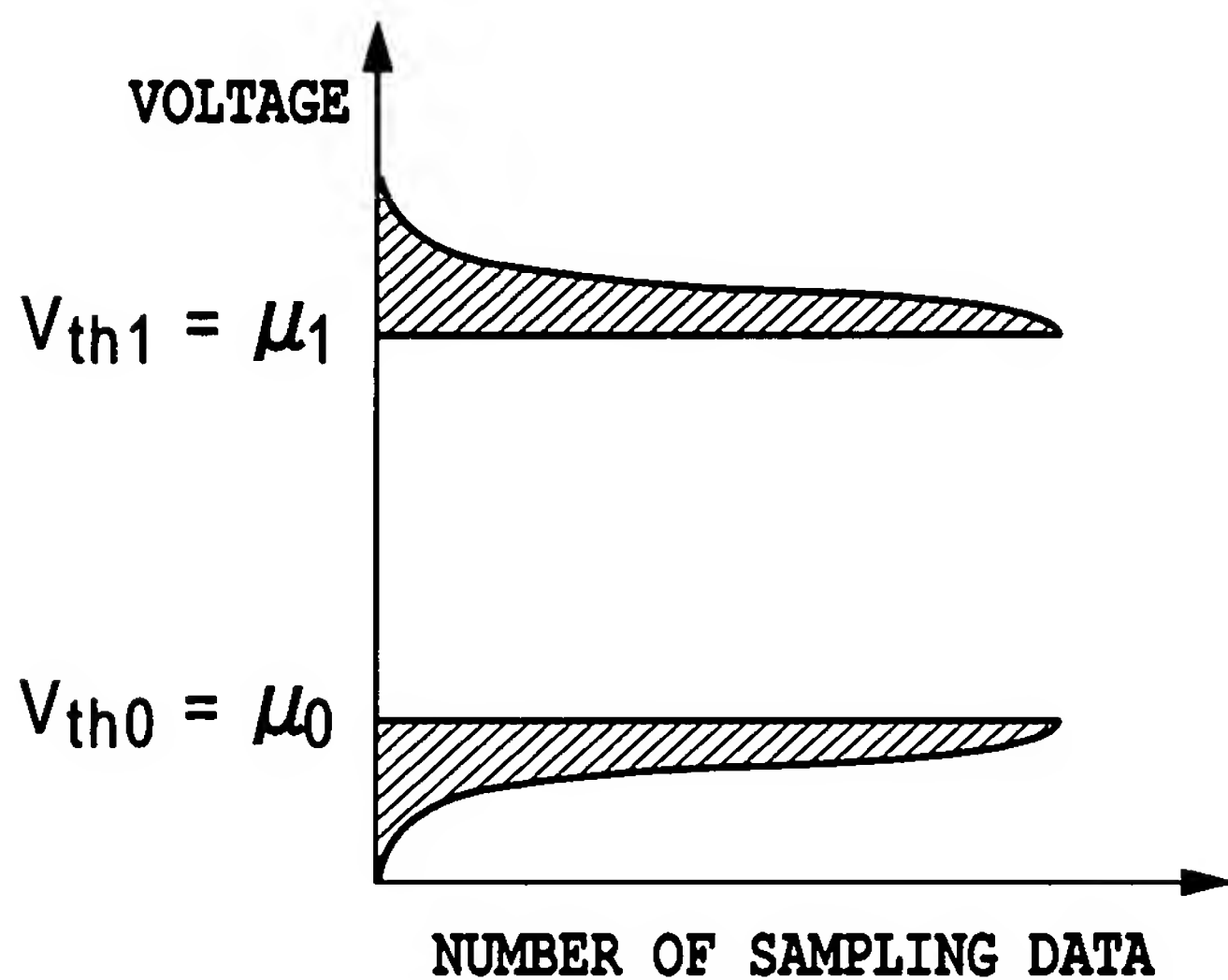
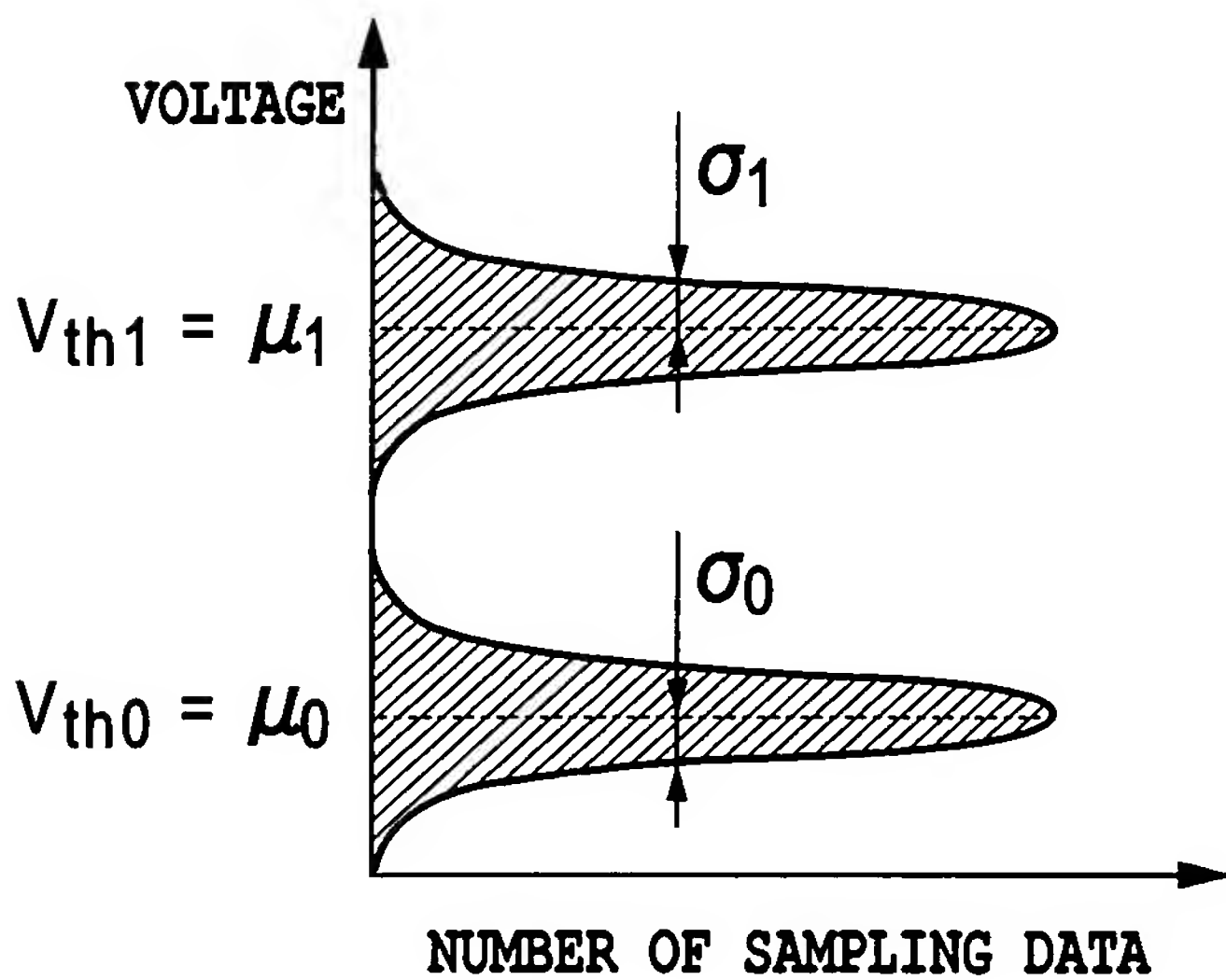


FIG.34



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FIG.35

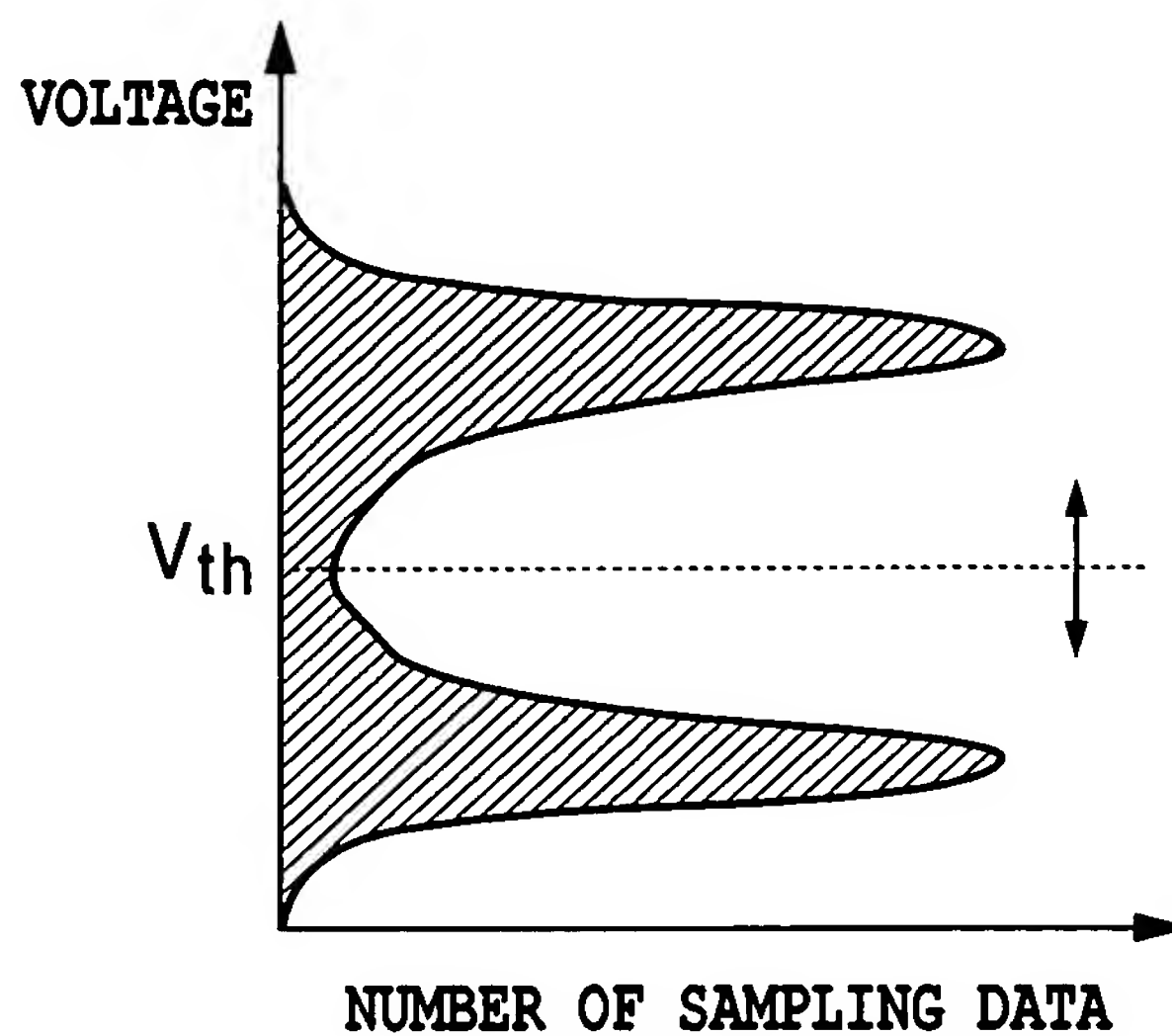
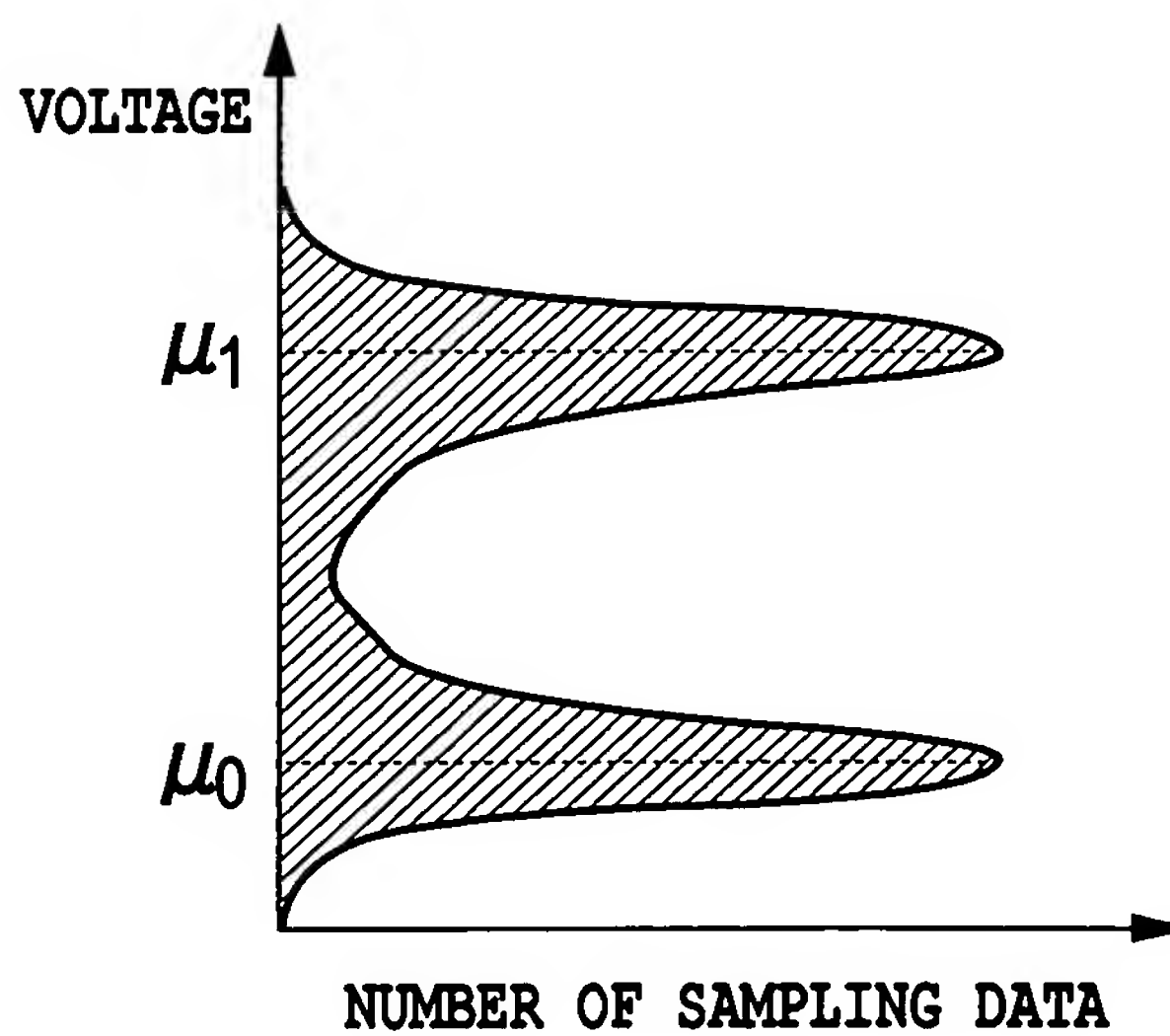


FIG.36



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FIG.37

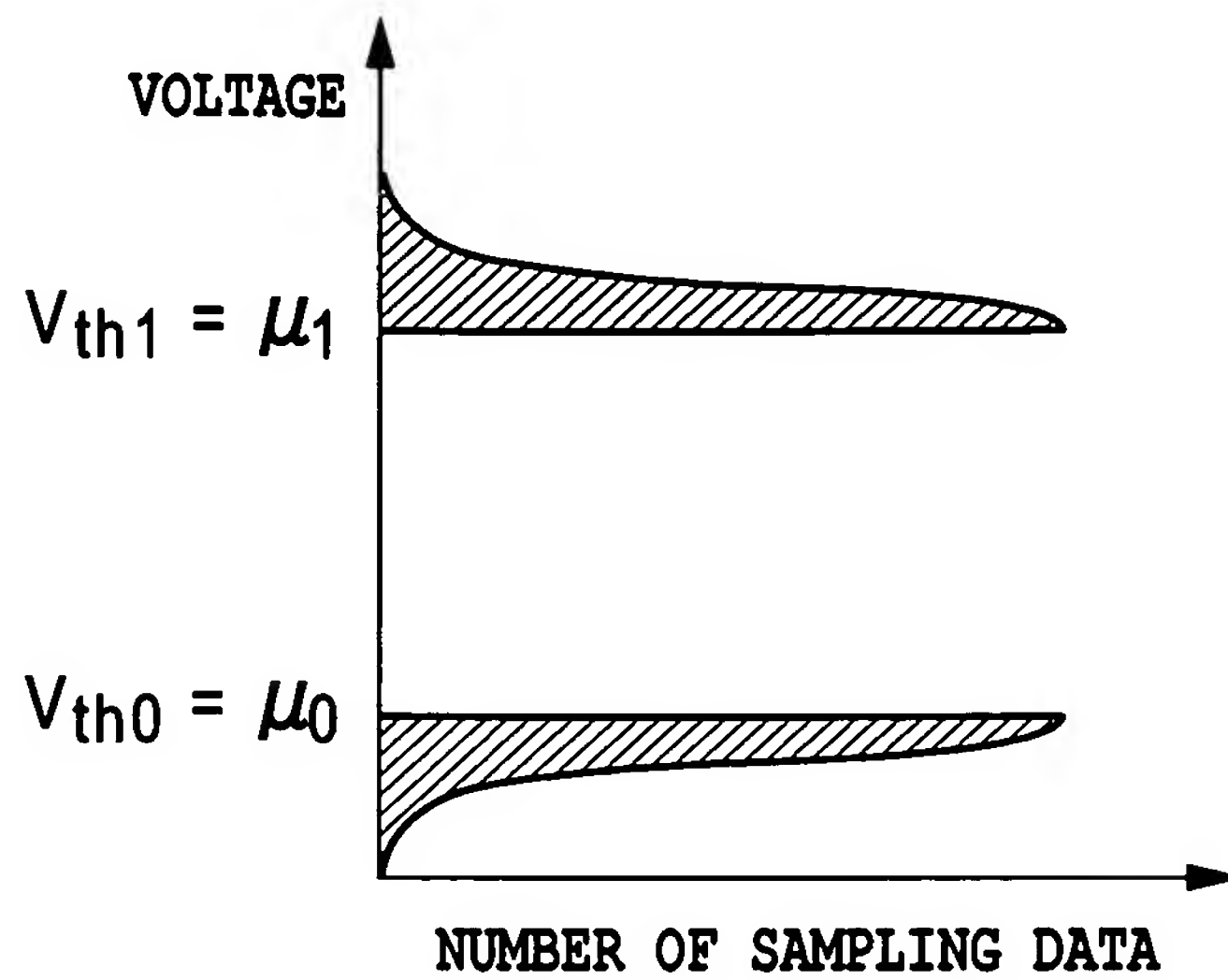


FIG.38

